FDC2x1x-Q1 Multi-Channel, High Resolution Capacitance-to-Digital Converter for Capacitive Sensing Applications

1 Features

- Qualified for automotive applications
- AEC-Q100 qualified with the following results:
  - Device temperature grade 1: –40°C to +125°C ambient operating temperature range
  - Device HBM ESD classification level 2
  - Device CDM ESD classification level C5
- EMI-resistant architecture
- Maximum output rates (one active channel):
  - 13.3kSPS (FDC2112-Q1, FDC2114-Q1)
  - 4.08kSPS (FDC2212-Q1, FDC2214-Q1)
- Maximum input capacitance: 250nF (at 10kHz with 1mH inductor)
- Sensor excitation frequency: 10kHz to 10MHz
- Number of channels: 2, 4
- Resolution: up to 28 bits
- RMS noise: 0.3fF at 100SPS and f_{SENSOR} = 5MHz
- Supply voltage: 2.7V to 3.6V
- power consumption: active: 2.1mA
- Low-power sleep mode: 35µA
- Shutdown: 200nA
- Interface: I^{2}C
- Temperature range: –40°C to +125°C

2 Applications

- Proximity sensor
- Gesture recognition
- Automotive door / kick sensors
- Level sensor for conductive liquids

3 Description

Capacitive sensing is a low-power, high-resolution contactless sensing technique that can be applied to a variety of applications ranging from proximity detection to gesture recognition. The sensor in a capacitive sensing system is any metal or conductor, allowing for highly flexible system design.
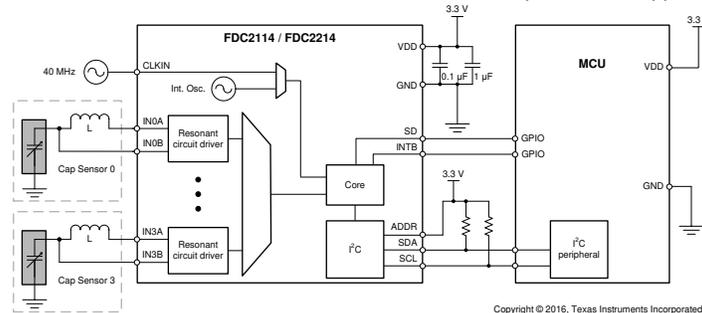
The main challenge limiting sensitivity in capacitive sensing applications is noise susceptibility of the sensors. With the FDC2x1x-Q1 resonant sensing architecture, performance can be maintained even in presence of fluorescent light.

The FDC2x1x-Q1 is a multi-channel family of high-resolution, high-speed capacitance-to-digital converters for implementing capacitive sensing solutions. The devices employ an innovative narrow-band based architecture to offer high rejection of noise while providing high resolution at high speed. The devices support a wide excitation frequency range, offering flexibility in system design.

Package Information

PART NUMBER	PACKAGE[1]	PACKAGE SIZE[2]
FDC2112-Q1	DNT (WSON, 12)	4mm × 4mm
FDC2114-Q1	RGH (WQFN, 16)	4mm × 4mm
FDC2212-Q1	DNT (WSON, 12)	4mm × 4mm
FDC2214-Q1	RGH (WQFN, 16)	4mm × 4mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.

Simplified Schematic

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Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*
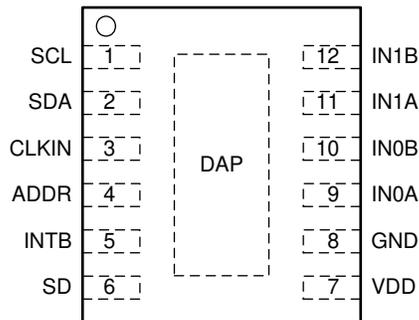
4 Pin Configuration and Functions

Figure 4-1. FDC2112/FDC2212 DNT Package 12-Pin WSON Top View
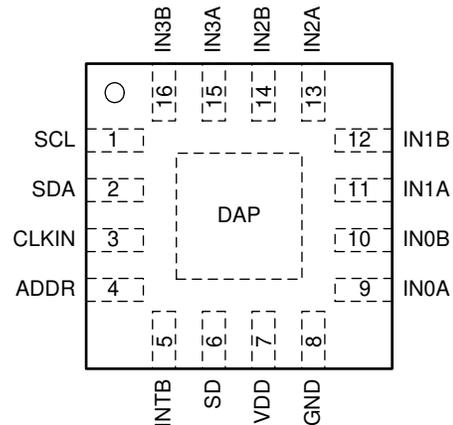
Figure 4-2. FDC2114/FDC2214 RGH Package 16-Pin WQFN Top View

Table 4-1. Pin Functions

PIN		TYPE[1]	DESCRIPTION
NO.	NAME		
1	SCL	I	I^{2}C clock input
2	SDA	I/O	12C data input/output
3	CLKIN	I	Controller Clock input. Tie this pin to GND if internal oscillator is selected
4	ADDR	I	I^{2}C Address selection pin: when ADDR=L, I^{2}C address = 0x2A, when ADDR=H, I^{2}C address = 0x2B.
5	INTB	O	Configurable Interrupt output pin
6	SD	I	Shutdown input
7	VDD	P	Power Supply
8	GND	G	Ground
9	IN0A	A	Capacitive sensor input 0
10	IN0B	A	Capacitive sensor input 0
11	IN1A	A	Capacitive sensor input 1
12	IN1B	A	Capacitive sensor input 1
13	IN2A	A	Capacitive sensor input 2 (FDC2114 / FDC2214 only)
14	IN2B	A	Capacitive sensor input 2 (FDC2114 / FDC2214 only)
15	IN3A	A	Capacitive sensor input 3 (FDC2114 / FDC2214 only)
16	IN3B	A	Capacitive sensor input 3 (FDC2114 / FDC2214 only)
DAP	DAP[2]	N/A	Connect to ground

(1) I = Input, O = Output, P=Power, G=Ground, A=Analog
(2) There is an internal electrical connection between the exposed Die Attach Pad (DAP) and the GND pin of the device. Although the DAP can be left floating, connect the DAP to the same potential as the GND pin of the device for best performance. Do not use the DAP as the primary ground for the device. The device GND pin must always be connected to ground.

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)[1]

		MIN	MAX	UNIT
VDD	Supply voltage		5	V
Vi	Voltage on any pin	−0.3	VDD + 0.3	V
IA	Input current on any INx pin	−8	8	mA
ID	Input current on any digital pin	−5	5	mA
T$_J$	Junction temperature	−55	150	°C
T$_{stg}$	Storage temperature	−65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			VALUE	UNIT
V$_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002[1]	±2000	V
		Charged-device model (CDM), per AEC Q100-011	±750	

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

5.3 Recommended Operating Conditions

Unless otherwise specified, all limits ensured for T$_A$ = 25°C, VDD = 3.3V

		MIN	NOM	MAX	UNIT
VDD	Supply voltage	2.7		3.6	V
T$_A$	Operating temperature	−40		125	°C

5.4 Thermal Information

THERMAL METRIC[1]		FDC2112 / FDC2212	FDC2214 / FDC2214	UNIT
		DNT (WSON)	RGH (WQFN)	
		12 PINS	16 PINS	
R$_{θJA}$	Junction-to-ambient thermal resistance	36.7	35.6	°C/W
R$_{θJC(top)}$	Junction-to-case (top) thermal resistance	36.2	36.2	°C/W
R$_{θJB}$	Junction-to-board thermal resistance	14	13.4	°C/W
ψ$_{JT}$	Junction-to-top characterization parameter	0.4	0.4	°C/W
ψ$_{JB}$	Junction-to-board characterization parameter	14.2	13.4	°C/W
R$_{θJC(bot)}$	Junction-to-case (bottom) thermal resistance	3.5	3.5	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application note.

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

5.5 Electrical Characteristics

Unless otherwise specified, all limits ensured for T_A = 25°C, VDD = 3.3V[1]

PARAMETER		TEST CONDITIONS[2]	MIN[3]	TYP[4]	MAX[3]	UNIT
POWER						
V_{DD}	Supply voltage	T_A = –40°C to 125°C	2.7		3.6	V
I_{DD}	Supply current (not including sensor current)[5]	CLKIN = 10MHz[6]		2.1		mA
I_{DDSL}	Sleep mode supply current[5]			35	60	µA
I_{SD}	Shutdown mode supply current[5]			0.2	1	µA
CAPACITIVE SENSOR						
$C_{SENSORMAX}$	Maximum sensor capacitance	1-mH inductor, 10kHz oscillation		250		nF
C_{IN}	Sensor pin parasitic capacitance			4		pF
N_{BITS}	Number of bits	FDC2112, FDC2114 RCOUNT ≥ 0x0400			12	bits
		FDC2212, FDC2214 RCOUNT = 0xFFFF			28	bits
f_{CS}	Maximum channel sample rate	FDC2112, FDC2114 single active channel continuous conversion, SCL = 400kHz			13.3	kSPS
		FDC2212, FDC2214 single active channel continuous conversion, SCL= 400kHz			4.08	kSPS
EXCITATION						
f_{SENSOR}	Sensor excitation frequency	T_A = –40°C to 125°C	0.01		10	MHz
$V_{SENSORMIN}$	Minimum sensor oscillation amplitude (pk)[7]			1.2		V
$V_{SENSORMAX}$	Maximum sensor oscillation amplitude (pk)			1.8		V
$I_{SENSORMAX}$	Sensor maximum current drive	HIGH_CURRENT_DRV = b0 DRIVE_CURRENT_CH0 = 0xF800		1.5		mA
		HIGH_CURRENT_DRV = b1 DRIVE_CURRENT_CH0 = 0xF800 Channel 0 only		6		mA

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

Unless otherwise specified, all limits ensured for T_A = 25°C, VDD = 3.3V[1]

PARAMETER		TEST CONDITIONS[2]	MIN[3]	TYP[4]	MAX[3]	UNIT
CONTROLLER CLOCK						
f_{CLKIN}	External controller clock input frequency (CLKIN)	T_A = –40°C to 125°C	2		40	MHz
$CLKIN_{DUTY\_MIN}$	External controller clock minimum acceptable duty cycle (CLKIN)			40%		
$CLKIN_{DUTY\_MAX}$	External controller clock maximum acceptable duty cycle (CLKIN)			60%		
V_{CLKIN_LO}	CLKIN low voltage threshold				$0.3V_{DD}$	V
V_{CLKIN_HI}	CLKIN high voltage threshold		$0.7 \times V_{DD}$			V
f_{INTCLK}	Internal controller clock frequency range		35	43.4	55	MHz
$T_{Cf\_int\_\mu}$	Internal controller clock temperature coefficient mean			–13		ppm/°C

(1) *Electrical Characteristics* values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that T_J = T_A. No guarantee of parametric performance is indicated in the electrical tables under conditions of internal self-heating where T_J > T_A. *Absolute Maximum Ratings* indicate junction temperature limits beyond which the device can be permanently degraded, either mechanically or electrically.

(2) Register values are represented as either binary (b is the prefix to the digits), or hexadecimal (0x is the prefix to the digits). Decimal values have no prefix.

(3) Limits are specified by testing, design, or statistical analysis at 25°C. Limits over the operating temperature range are ensured through correlations using statistical quality control (SQC) method.

(4) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values can vary over time and also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

(5) I^2C read/write communication and pullup resistors current through SCL, SDA not included.

(6) Sensor capacitor: 1 layer, 20.9 × 13.9mm, Bourns CMH322522-180KL sensor inductor with L=18µH and 33pF 1% COG/NP0 Target: Grounded aluminum plate (176 × 123mm), Channel = Channel 0 (continuous mode) CLKIN = 40MHz, CHx_FIN_SEL = b10, CHx_FREF_DIVIDER = b00 0000 0001 CH0_RCOUNT = 0xFFFF, SETTLECOUNT_CH0 = 0x0100, DRIVE_CURRENT_CH0 = 0x7800.

(7) Lower $V_{SENSORMIN}$ oscillation amplitudes can be used, but will result in lower SNR.

5.6 Timing Requirements

		MIN	NOM	MAX	UNIT
$t_{SDWAKEUP}$	Wake-up time from SD high-low transition to I^2C readback			2	ms
$t_{SLEEPWAKEUP}$	Wake-up time from sleep mode			0.05	ms
$t_{WD-TIMEOUT}$	Sensor recovery time (after watchdog timeout)		5.2		ms
I^2C TIMING CHARACTERISTICS					
f_{SCL}	Clock frequency	10		400	kHz
t_{LOW}	Clock low time	1.3			µs
t_{HIGH}	Clock high time	0.6			µs
$t_{HD;STA}$	Hold time (repeated) START condition: after this period, the first clock pulse is generated	0.6			µs
$t_{SU;STA}$	Setup time for a repeated START condition	0.6			µs
$t_{HD;DAT}$	Data hold time	0			µs
$t_{SU;DAT}$	Data setup time	100			ns
$t_{SU;STO}$	Setup time for STOP condition	0.6			µs
t_{BUF}	Bus free time between a STOP and START condition	1.3			µs
$t_{VD;DAT}$	Data valid time			0.9	µs
$t_{VD;ACK}$	Data valid acknowledge time			0.9	µs
t_{SP}	Pulse width of spikes that must be suppressed by the input filter[1]			50	ns

5.7 Switching Characteristics - I²C

Unless otherwise specified, all limits ensured for T_A = 25°C, VDD = 3.3V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOLTAGE LEVELS						
V_{IH}	Input high voltage		$0.7 \times V_{DD}$			V
V_{IL}	Input low voltage				$0.3 \times V_{DD}$	V
V_{OL}	Output low voltage (3mA sink current)				0.4	V
HYS	Hysteresis			$0.1 \times V_{DD}$		V

(1)   This parameter is specified by design and/or characterization and is not tested in production.

Figure 5-1. I²C Timing

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*
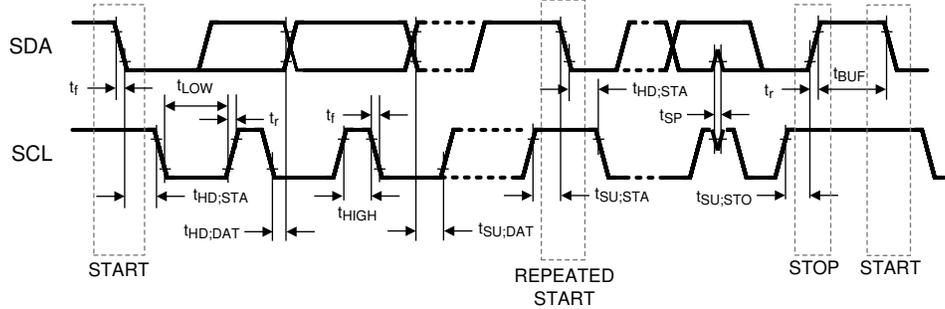
5.8 Typical Characteristics

Common test conditions (unless specified otherwise): Sensor capacitor: 1 layer, 20.9mm × 13.9mm, Bourns CMH322522-180KL sensor inductor with L = 18µH and 33pF 1% COG/NP0 Target: Grounded aluminum plate (176mm × 123mm), Channel = Channel 0 (continuous mode) CLKIN = 40MHz, CHx_FIN_SEL = b01, CHx_FREF_DIVIDER = b00 0000 0000 0001 CH0_RCOUNT = 0xFFFF, SETTLECOUNT_CH0 = 0x0100, DRIVE_CURRENT_CH0 = 0x7800.

Includes 1.57mA sensor current

–40°C to +125°C

Figure 5-2. Active Mode I_DD vs Temperature

Includes 1.57mA sensor current

Figure 5-3. Active Mode I_DD vs V_DD

–40°C to +125°C

Figure 5-4. Sleep Mode I_DD vs Temperature

Figure 5-5. Sleep Mode I_DD vs V_DD

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*
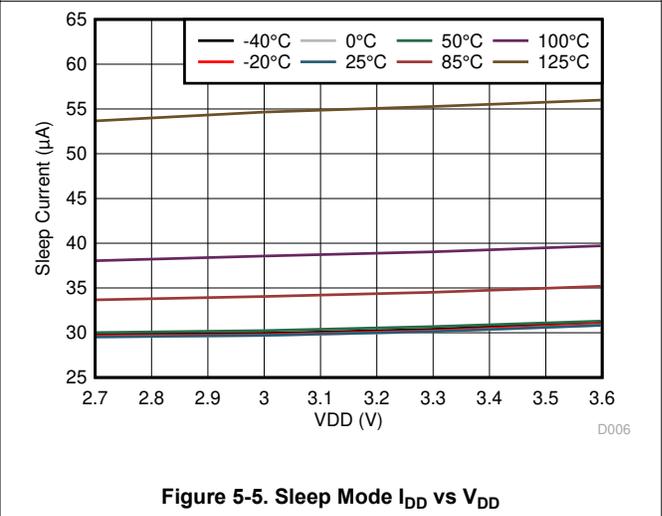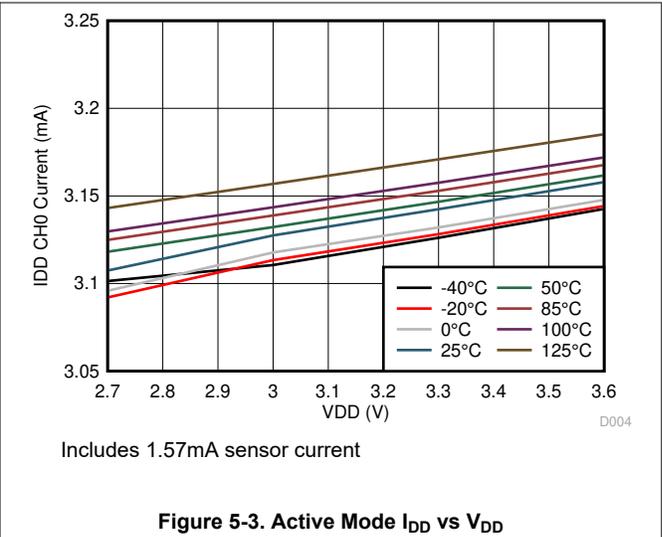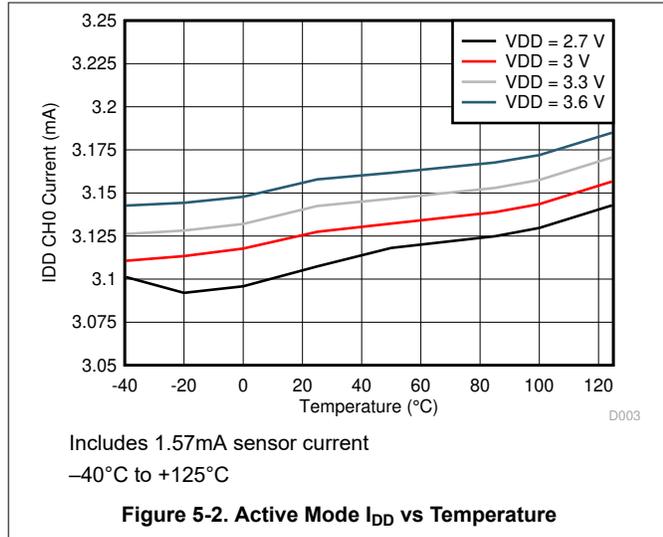
5.8 Typical Characteristics (continued)

Common test conditions (unless specified otherwise): Sensor capacitor: 1 layer, 20.9mm × 13.9mm, Bourns CMH322522-180KL sensor inductor with L = 18µH and 33pF 1% COG/NP0 Target: Grounded aluminum plate (176mm × 123mm), Channel = Channel 0 (continuous mode) CLKIN = 40MHz, CHx_FIN_SEL = b01, CHx_FREF_DIVIDER = b00 0000 0001 CH0_RCOUNT = 0xFFFF, SETTLECOUNT_CH0 = 0x0100, DRIVE_CURRENT_CH0 = 0x7800.
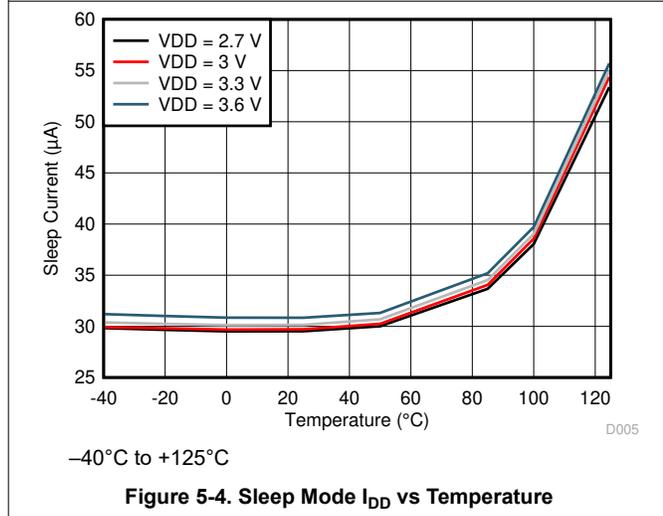

–40°C to +125°C

Figure 5-6. Shutdown Mode I_{DD} vs Temperature

Figure 5-7. Shutdown Mode I_{DD} vs V_{DD}

–40°C to +125°C
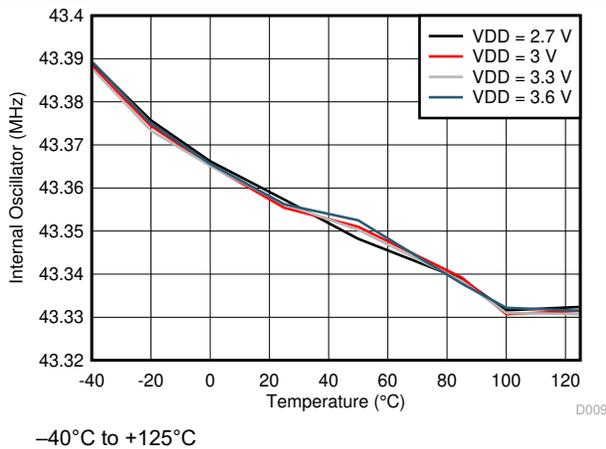
Figure 5-8. Internal Oscillator Frequency vs Temperature
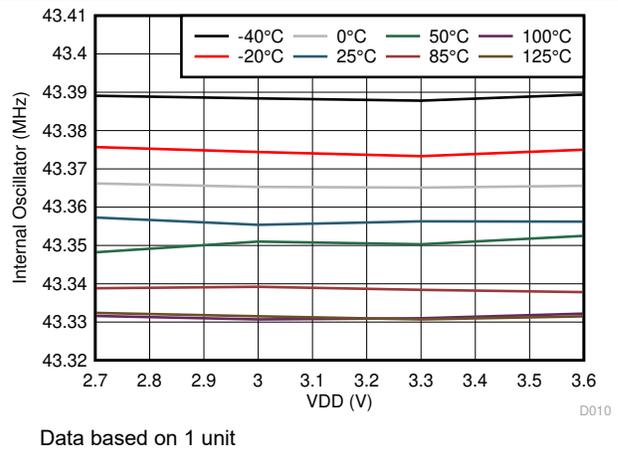
Data based on 1 unit

Figure 5-9. Internal Oscillator Frequency vs V_{DD}

6 Detailed Description

6.1 Overview

The FDC2112, FDC2114, FDC2212, and FDC2214 are high-resolution, multichannel capacitance-to-digital converters for implementing capacitive sensing solutions. In contr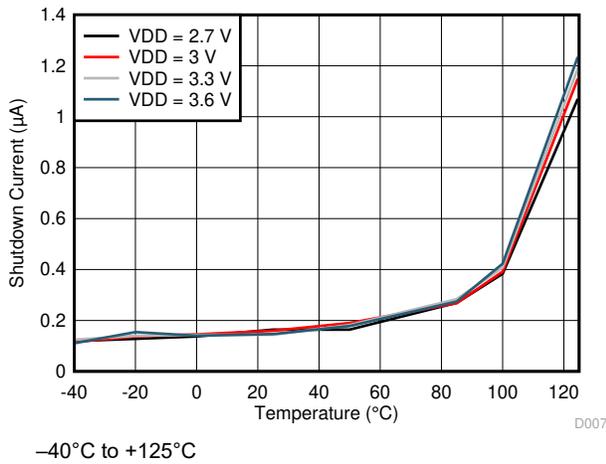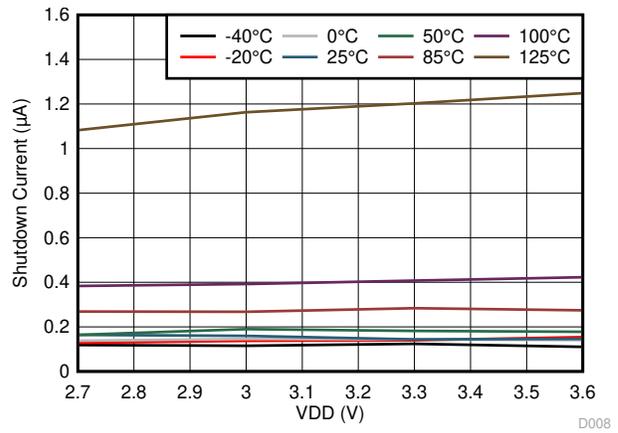ast to traditional switched-capacitance architectures, the FDC2112, FDC2114, FDC2212, and FDC2214 employ an L-C resonator, also known as L-C tank, as a sensor. The narrow-band architecture allows unprecedented EMI immunity and greatly reduced noise floor when compared to other capacitive sensing solutions.

Using this approach, a change in capacitance of the L-C tank can be observed as a shift in the resonant frequency. Using this principle, the FDC is a capacitance-to-digital converter (FDC) that measures the oscillation frequency of an LC resonator. The device outputs a digital value that is proportional to frequency. This frequency measurement can be converted to an equivalent capacitance

6.2 Functional Block Diagrams
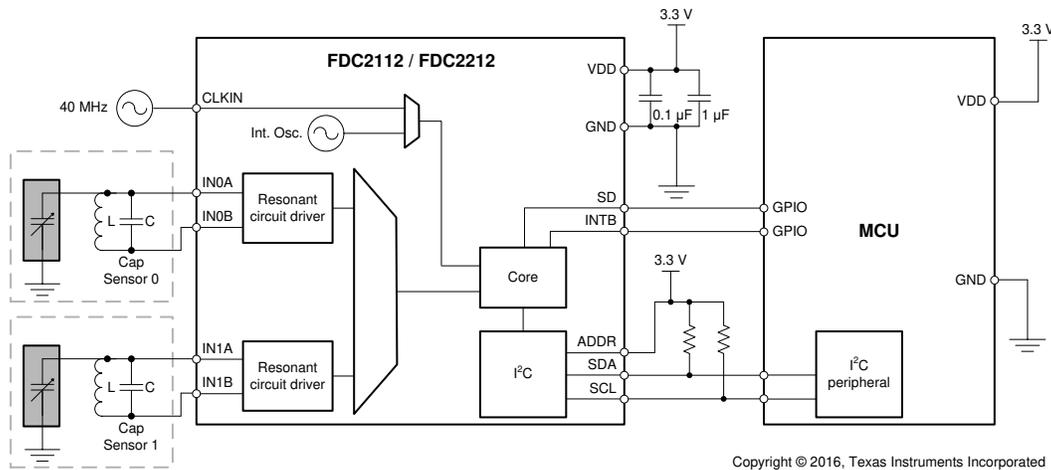
Figure 6-1. Block Diagram for the FDC2112 and FDC2212
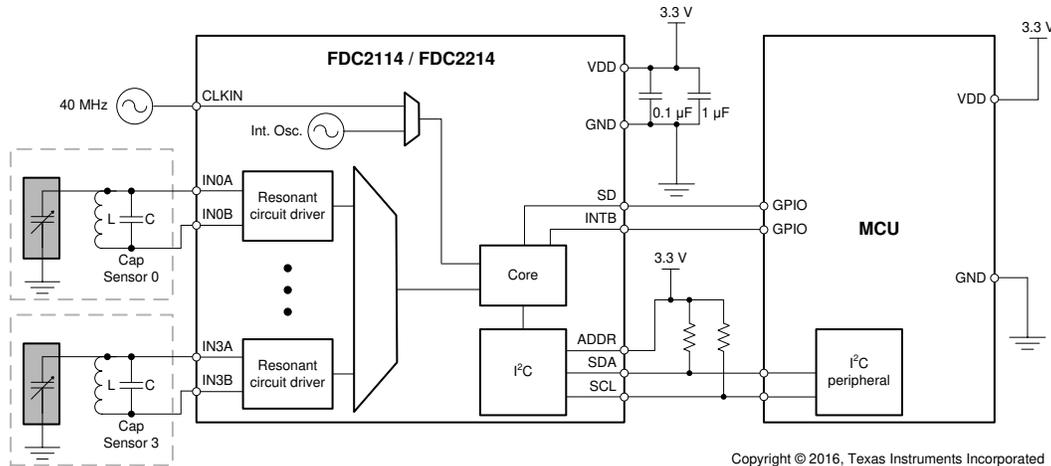
Figure 6-2. Block Diagram for the FDC2114 and FDC2214

The FDC is composed of front-end resonant circuit drivers, followed by a multiplexer that sequences through the active channels, connecting them to the core that measures and digitizes the sensor frequency (f_{SENSOR}). The core uses a reference frequency (f_{REF}) to measure the sensor frequency. f_{REF} is derived from either an internal reference clock (oscillator), or an externally supplied clock. The digitized output for each channel is proportional to the ratio of f_{SENSOR}/f_{REF}. The I²C interface is used to support device configuration and to transmit the digitized

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

frequency values to a host processor. The FDC can be placed in shutdown mode, saving current, using the SD pin. The INTB pin may be configured to notify the host of changes in system status.

6.3 Feature Description

6.3.1 Clocking Architecture

Figure 6-3 shows the clock dividers and multiplexers of the FDC.
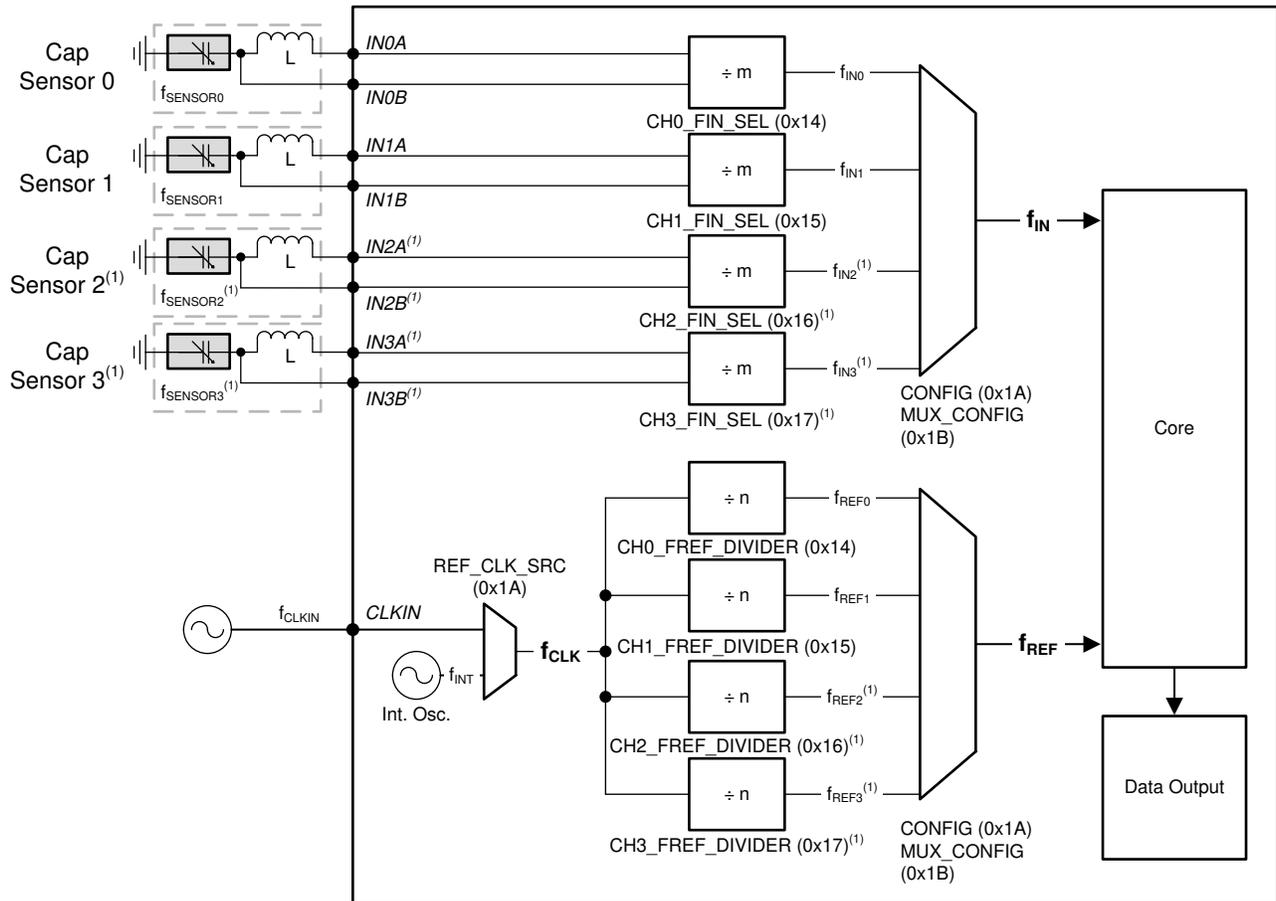
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A.   FDC2114 / FDC2214 only

Figure 6-3. Clocking Diagram

In Figure 6-3, the key clocks are f_{IN}, f_{REF}, and f_{CLK}. f_{CLK} is selected from either the internal clock source or external clock source (CLKIN). The frequency measurement reference clock, f_{REF}, is derived from the f_{CLK} source. TI recommends that precision applications use an external controller clock that offers the stability and accuracy requirements needed for the application. The internal oscillator may be used in applications that require low cost and do not require high precision. The f_{INx} clock is derived from sensor frequency for a channel x, $f_{SENSORx}$. f_{REFx} and f_{INx} must meet the requirements listed in Table 6-1, depending on whether f_{CLK} (controller clock) is the internal or external clock.

Table 6-1. Clock Configuration Requirements

MODE[1]	CLKIN SOURCE	VALID f_{REFx} RANGE (MHz)	VALID f_{INx} RANGE	SET CHx_FIN_SEL to [2]	SET CHx_SETTLECOUNT to	SET CHx_RCOUNT to
Multi-channel	Internal	$f_{REFx} \leq 55$	$< f_{REFx}/4$	Differential sensor configuration: b01: 0.01MHz to 8.75MHz (divide by 1) b10: 5MHz to 10MHz (divide by 2) Single-ended sensor configuration b10: 0.01MHz to 10MHz (divide by 2)	> 3	> 8
	External	$f_{REFx} \leq 40$				
Single-channel	Either external or internal	$f_{REFx} \leq 35$				

(1)   Channels 2 and 3 are only available for FDC2114 and FDC2214.
(2)   Refer to *Sensor Configuration* for information on differential and single-ended sensor configurations.

Table 6-2 shows the clock configuration registers for all channels.

Table 6-2. Clock Configuration Registers

CHANNEL[1]	CLOCK	REGISTER	FIELD [BIT(S)]	VALUE
All	f_{CLK} = Controller Clock Source	CONFIG, addr 0x1A	REF_CLK_SRC [9]	b0 = internal oscillator is used as the controller clock b1 = external clock source is used as the controller clock
0	f_{REF0}	CLOCK_DIVIDERS_CH0, addr 0x14	CH0_FREF_DIVIDER [9:0]	$f_{REF0} = f_{CLK}$ / CH0_FREF_DIVIDER
1	f_{REF1}	CLOCK_DIVIDERS_CH1, addr 0x15	CH1_FREF_DIVIDER [9:0]	$f_{REF1} = f_{CLK}$ / CH1_FREF_DIVIDER
2	f_{REF2}	CLOCK_DIVIDERS_CH2, addr 0x16	CH2_FREF_DIVIDER [9:0]	$f_{REF2} = f_{CLK}$ / CH2_FREF_DIVIDER
3	f_{REF3}	CLOCK_DIVIDERS_CH3, addr 0x17	CH3_FREF_DIVIDER [9:0]	$f_{REF3} = f_{CLK}$ / CH3_FREF_DIVIDER
0	f_{IN0}	CLOCK_DIVIDERS_CH0, addr 0x14	CH0_FIN_SEL [13:12]	$f_{IN0} = f_{SENSOR0}$ / CH0_FIN_SEL
1	f_{IN1}	CLOCK_DIVIDERS_CH1, addr 0x15	CH1_FIN_SEL [13:12]	$f_{IN1} = f_{SENSOR1}$ / CH1_FIN_SEL
2	f_{IN2}	CLOCK_DIVIDERS_CH2, addr 0x16	CH2_FIN_SEL [13:12]	$f_{IN2} = f_{SENSOR2}$ / CH2_FIN_SEL
3	f_{IN3}	CLOCK_DIVIDERS_CH3, addr 0x17	CH3_FIN_SEL [13:12]	$f_{IN3} = f_{SENSOR3}$ / CH3_FIN_SEL

(1)   Channels 2 and 3 are only available for FDC2114 and FDC2214

6.3.2 Multi-Channel and Single-Channel Operation

The multi-channel package of the FDC enables the user to save board space and support flexible system design. For example, temperature drift can often cause a shift in component values, resulting in a shift in resonant frequency of the sensor. Using a second sensor as a reference provides the capability to cancel out a temperature shift. When operated in multi-channel mode, the FDC sequentially samples the active channels. In single-channel mode, the FDC samples a single channel, which is selectable. Table 6-3 shows the registers and values that are used to configure either multi-channel or single-channel modes.

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

Table 6-3. Single- and Multi-Channel Configuration Registers

MODE	REGISTER	FIELD [BIT(S)]	VALUE
Single channel	CONFIG, addr 0x1A	ACTIVE_CHAN [15:14]	00 = chan 0
			01 = chan 1
			10 = chan 2
			11 = chan 3
	MUX_CONFIG addr 0x1B	AUTOSCAN_EN [15]	0 = continuous conversion on a single channel (default)
Multi-channel	MUX_CONFIG addr 0x1B	AUTOSCAN_EN [15]	1 = continuous conversion on multiple channels
	MUX_CONFIG addr 0x1B	RR_SEQUENCE [14:13]	00 = Ch0, Ch 1
			01 = Ch0, Ch 1, Ch 2
			10 = Ch0, CH1, Ch2, Ch3

The digitized sensor measurement for each channel (DATAx) represents the ratio of the sensor frequency to the reference frequency.

The data output (DATAx) of the FDC2112 and FDC2114 is expressed as the 12 MSBs of a 16-bit result:

$$\text{DATA}_x = \frac{f_{\text{SENSORx}} * 2^{12}}{f_{\text{REFx}}}$$

(1)

The data output (DATAx) of the FDC2212 and FDC2214 is expressed as:

$$\text{DATA}_x = \frac{f_{\text{SENSORx}} * 2^{28}}{f_{\text{REFx}}}$$

(2)

Table 6-4 lists the registers that contain the fixed point sample values for each channel.

Table 6-4. Sample Data Registers

CHANNEL[2]	REGISTER[1]	FIELD NAME [BITS(S)] AND VALUE (FDC2112, FDC2114)	FIELD NAME [BITS(S)] AND VALUE (FDC2212, FDC2214) [3] [4]
0	DATA_CH0, addr 0x00	DATA0 [11:0]: 12 bits of the 16 bit conversion result. 0x000 = under range 0xfff = over range	DATA0 [27:16]: 12 MSBs of the 28 bit conversion result
	DATA_LSB_CH0, addr 0x01	Not applicable	DATA0 [15:0]: 16 LSBs of the 28 bit conversion result
1	DATA_CH1, addr 0x02	DATA1 [11:0]: 12 bits of the 16 bit conversion result. 0x000 = under range 0xfff = over range	DATA1 [27:16]: 12 MSBs of the 28 bit conversion result
	DATA_LSB_CH1, addr 0x03	Not applicable	DATA1 [15:0]: 16 LSBs of the 28 bit conversion result
2	DATA_CH2, addr 0x04	DATA2 [11:0]: 12 bits of the 16 bit conversion result. 0x000 = under range 0xfff = over range	DATA2 [27:16]: 12 MSBs of the 28 bit conversion result
	DATA_LSB_CH2, addr 0x05	Not applicable	DATA2 [15:0]: 16 LSBs of the 28 bit conversion result

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Table 6-4. Sample Data Registers (continued)

CHANNEL[2]	REGISTER[1]	FIELD NAME [BITS(S)] AND VALUE (FDC2112, FDC2114)	FIELD NAME [BITS(S)] AND VALUE (FDC2212, FDC2214) [3] [4]
3	DATA_CH3, addr 0x06	DATA3 [11:0]: 12 bits of the 16 bit conversion result. 0x000 = under range 0xfff = over range	DATA3 [27:16]: 12 MSBs of the 28 bit conversion result
	DATA_LSB_CH3, addr 0x07	Not applicable	DATA3 [15:0]: 16 LSBs of the 28 bit conversion result

(1) The DATA_CHx.DATAx register must always be read first, followed by the DATA_LSB_ CHx.DATAx register of the same channel to ensure data coherency.
(2) Channels 2 and 3 are only available for FDC2114 and FDC2214.
(3) A DATA value of 0x0000000 = under range for FDC2212/FDC2214.
(4) A DATA value of 0xFFFFFFF = over range for FDC2212/FDC2214.

When the FDC sequences through the channels in multi-channel mode, the dwell time interval for each channel is the sum of three parts:

1. sensor activation time
2. conversion time
3. channel switch delay

The sensor activation time is the amount of settling time required for the sensor oscillation to stabilize, as shown in Figure 6-4. The settling wait time is programmable, and TI recommends setting the wait time to a value that is long enough to allow stable oscillation. The settling wait time for channel x is given by:

$$t_{Sx} = (CHX\_SETTLECOUNT \times 16)/f_{REFx} \tag{3}$$

Table 6-5 illustrates the registers and values for configuring the settling time for each channel.
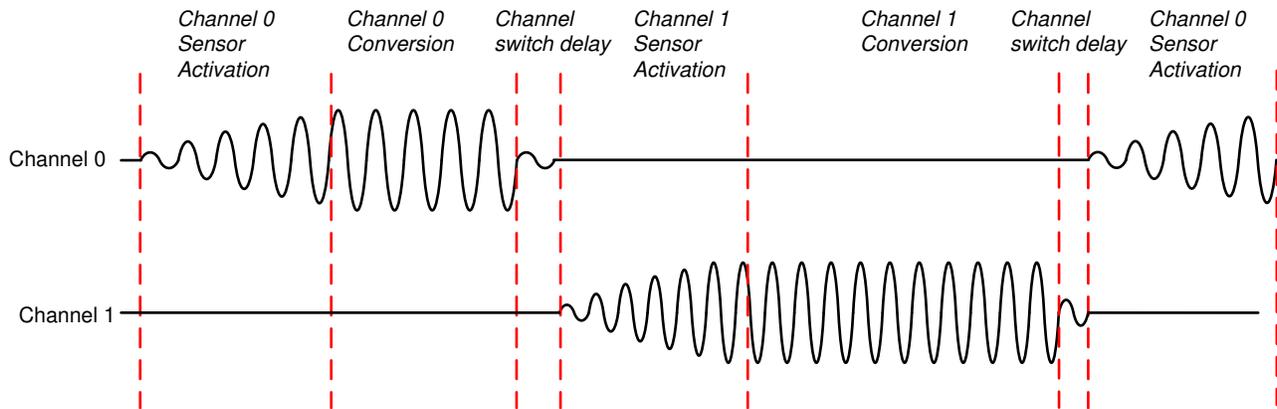

Figure 6-4. Multi-Channel Mode Sequencing

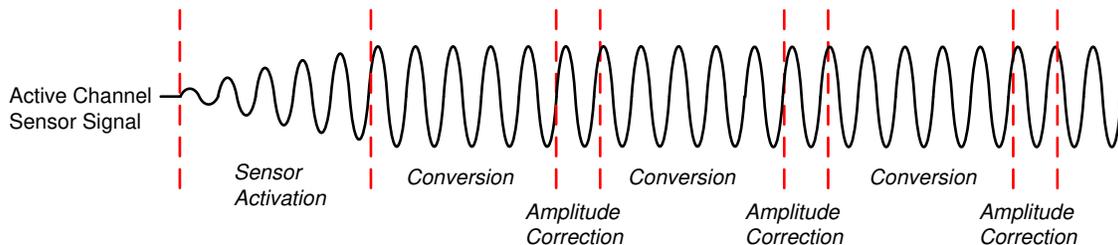**Figure 6-5. Single-Channel Mode Sequencing**

Table 6-5. Settling Time Register Configuration

CHANNEL[1]	REGISTER	FIELD	CONVERSION TIME[2]
0	SETTLECOUNT_CH0, addr 0x10	CH0_SETTLECOUNT [15:0]	(CH0_SETTLECOUNT*16)/f_{REF0}

Table 6-5. Settling Time Register Configuration (continued)

CHANNEL[1]	REGISTER	FIELD	CONVERSION TIME[2]
1	SETTLECOUNT_CH1, addr 0x11	CH1_SETTLECOUNT [15:0]	(CH1_SETTLECOUNT*16)/f_{REF1}
2	SETTLECOUNT_CH2, addr 0x12	CH2_SETTLECOUNT [15:0]	(CH2_SETTLECOUNT*16)/f_{REF2}
3	SETTLECOUNT_CH3, addr 0x13	CH3_SETTLECOUNT [15:0]	(CH3_SETTLECOUNT*16)/f_{REF3}

(1)   Channels 2 and 3 are available only in the FDC2114 and FDC2214.
(2) f_{REFx} is the reference frequency configured for the channel.

The SETTLECOUNT for any channel x must satisfy:

- $CHx\_SETTLECOUNT > V_{pk} \times f_{REFx} \times C \times \pi^2 / (32 \times IDRIVE_X)$ (4)

- – where
    - – V_{pk} = Peak oscillation amplitude at the programmed IDRIVE setting
    - – f_{REFx} = Reference frequency for Channel x
    - – C = sensor capacitance including parasitic PCB capacitance
    - – $IDRIVE_X$ = setting programmed into the IDRIVE register in amps
- Round the result to the next highest integer (for example, if Equation 4 recommends a minimum value of 6.08, program the register to 7 or higher).
- The conversion time represents the number of reference clock cycles used to measure the sensor frequency and is set by the CHx_RCOUNT register for the channel. The conversion time for any channel x is:

- $t_{Cx} = (CHx\_RCOUNT \times 16 + 4) / f_{REFx}$ (5)

- The reference count value must be chosen to support the required number of effective bits (ENOB). For example, if an ENOB of 13 bits is required, then a minimum conversion time of 2^{13} = 8192 clock cycles is required. 8192 clock cycles correspond to a CHx_RCOUNT value of 0x0200.

Table 6-6. Conversion Time Configuration Registers, Channels 0 - 3 [1]

CHANNEL	REGISTER	FIELD [BIT(S)]	CONVERSION TIME
0	RCOUNT_CH0, addr 0x08	CH0_RCOUNT [15:0]	(CH0_RCOUNT × 16)/f_{REF0}
1	RCOUNT_CH1, addr 0x09	CH1_RCOUNT [15:0]	(CH1_RCOUNT × 16)/f_{REF1}
2	RCOUNT_CH2, addr 0x0A	CH2_RCOUNT [15:0]	(CH2_RCOUNT × 16)/f_{REF2}
3	RCOUNT_CH3, addr 0x0B	CH3_RCOUNT [15:0]	(CH3_RCOUNT × 16)/f_{REF3}

(1)   Channels 2 and 3 are available only for FDC2114 and FDC2214.

The typical channel switch delay time between the end of conversion and the beginning of sensor activation of the subsequent channel is:

Channel Switch Delay = 692ns + 5 / f_{ref} (6)

The deterministic conversion time of the FDC allows data polling at a fixed interval. For example, if the programmed SETTLECOUNT is 128 F_{REF} cycles (SETTLECOUNT = 0x0008) and RCOUNT is 512 F_{REF} cycles (RCOUNT=0x0020), then one conversion takes 3.2ms (sensor-activation time) + 12.8ms (conversion time) + 0.8µs (channel-switch delay) = 16.0ms per channel. If the FDC is configured for dual-channel operation by setting AUTOSCAN_EN = 1 and RR_SEQUENCE = 00, then one full set of conversion results is available from the data registers every 32ms.

A data ready flag (DRDY) is also available for interrupt driven system designs (see the STATUS register description in *Register Maps*.

6.3.3 Current Drive Control Registers

The registers listed in Table 6-7 are used to control the sensor drive current. Follow the recommendations listed in the last column of the table.

Table 6-7. Current Drive Control Registers

CHANNEL[1]	REGISTER	FIELD [BIT(S)]	VALUE
All	CONFIG, addr 0x1A	SENSOR_ACTIVATE_SEL [11]	Sets current drive for sensor activation. Recommended value is b0 (full current mode).
0	CONFIG, addr 0x1A	HIGH_CURRENT_DRV [6]	b0 = normal current drive (1.5mA) b1 = Increased current drive (> 1.5mA) for Ch 0 in single channel mode only. Cannot be used in multi-channel mode.
0	DRIVE_CURRENT_CH0, addr 0x1E	CH0_IDRIVE [15:11]	Drive current used during the settling and conversion time for Ch. 0. Set such that $1.2V \leq$ sensor oscillation amplitude (pk) $\leq 1.8V$
1	DRIVE_CURRENT_CH1, addr 0x1F	CH1_IDRIVE [15:11]	Drive current used during the settling and conversion time for Ch. 1. Set such that $1.2V \leq$ sensor oscillation amplitude (pk) $\leq 1.8V$
2	DRIVE_CURRENT_CH2, addr 0x20	CH2_IDRIVE [15:11]	Drive current used during the settling and conversion time for Ch. 2. Set such that $1.2V \leq$ sensor oscillation amplitude (pk) $\leq 1.8V$
3	DRIVE_CURRENT_CH3, addr 0x21	CH3_IDRIVE [15:11]	Drive current used during the settling and conversion time for Ch. 3 . Set such that $1.2V \leq$ sensor oscillation amplitude (pk) $\leq 1.8V$

(1)   Channels 2 and 3 are available for FDC2114 and FDC2214 only.

Program the CHx_IDRIVE field such that the sensor oscillates at an amplitude between 1.2Vpk ($V_{SENSORMIN}$) and 1.8Vpk ($V_{SENSORMAX}$). An IDRIVE value of 00000 corresponds to 16µA, and IDRIVE = b11111 corresponds to 1563µA.

A high sensor current drive mode can be enabled to drive sensor coils with > 1.5mA on channel 0, only in single channel mode. This feature can be used when the sensor minimum recommended oscillation amplitude of 1.2V cannot be achieved with the highest IDRIVE setting. Set the HIGH_CURRENT_DRV register bit to b1 to enable this mode.

6.3.4 Device Status Registers

The registers listed in Table 6-8 may be used to read device status.

Table 6-8. Status Registers

CHANNEL[1]	REGISTER	FIELDS [BIT(S)]	VALUES
All	STATUS, addr 0x18	12 fields are available that contain various status bits [15:0]	Refer to *Register Maps* for a description of the individual status bits.
All	STATUS_CONFIG, addr 0x19	12 fields are available that are used to configure status reporting [15:0]	Refer to *Register Maps* for a description of the individual error configuration bits.

(1)   Channels 2 and 3 are available for FDC2114 and FDC2114 only.

See the STATUS and STATUS_CONFIG register description in *Register Maps*. These registers can be configured to trigger an interrupt on the INTB pin for certain events. The following conditions must be met:

1. The error or status register must be unmasked by enabling the appropriate register bit in the STATUS_CONFIG register
2. The INTB function must be enabled by setting CONFIG.INTB_DIS to 0

When a bit field in the STATUS register is set, the entire STATUS register content is held until read or until the DATA_CHx register is read. Reading also deasserts INTB.

Interrupts are cleared by one of the following events:

1. Entering sleep mode
2. Power-on reset (POR)
3. Device enters shutdown mode (SD is asserted)
4. S/W reset
5. I^{2}C read of the STATUS register: Reading the STATUS register clears any error status bit set in STATUS along with the ERR_CHAN field and deassert INTB

Setting register CONFIG.INTB_DIS to b1 disables the INTB function and holds the INTB pin high.

6.3.5 Input Deglitch Filter

The input deglitch filter suppresses EMI and ringing above the sensor frequency. The input deglitch filter does not impact the conversion result as long as its bandwidth is configured to be above the maximum sensor frequency. The input deglitch filter can be configured in MUX_CONFIG.DEGLITCH register field as shown in Table 6-9. For optimal performance, TI recommends selection of the lowest setting that exceeds the sensor oscillation frequency. For example, if the maximum sensor frequency is 2MHz, choose MUX_CONFIG.DEGLITCH = b100 (3.3MHz).

Table 6-9. Input Deglitch Filter Register

CHANNEL[1]	MUX_CONFIG.DEGLITCH (addr 0x1B) REGISTER VALUE	DEGLITCH FREQUENCY
ALL	001	1MHz
ALL	100	3.3MHz
ALL	101	10MHz
ALL	011	33MHz

(1)   Channels 2 and 3 are available for FDC2114 / FDC2214 only.

6.4 Device Functional Modes

6.4.1 Start-Up Mode

When the FDC powers up, the FDC enters sleep mode and waits for configuration. When the device is configured, exit sleep mode by setting CONFIG.SLEEP_MODE_EN to b0.

TI recommends configuring the FDC while in sleep mode. If a setting on the FDC needs to be changed, return the device to sleep mode, change the appropriate register, and then exit sleep mode.

6.4.2 Normal (Conversion) Mode

When operating in the normal (conversion) mode, the FDC is periodically sampling the frequency of the sensor(s) and generating sample outputs for the active channel(s).

6.4.3 Sleep Mode

Sleep mode is entered by setting the CONFIG.SLEEP_MODE_EN register field to 1. While in this mode, the device configuration is maintained. To exit sleep mode, set the CONFIG.SLEEP_MODE_EN register field to 0. After setting CONFIG.SLEEP_MODE_EN to b0, sensor activation for the first conversion begins after 16,384 f_{INT} clock cycles. While in sleep mode the I^{2}C interface is functional so that register reads and writes can be performed. While in sleep mode, no conversions are performed. In addition, entering sleep mode clears conversion results, any error condition, and deassert the INTB pin.

6.4.4 Shutdown Mode

When the SD pin is set to high, the FDC enters shutdown mode. Shutdown mode is the lowest power state. To exit shutdown mode, set the SD pin to low. Entering shutdown mode returns all registers to their default state.

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While in shutdown mode, no conversions are performed. In addition, entering shutdown mode clears any error condition and deassert the INTB pin. While the device is in shutdown mode, is not possible to read to or write from the device via the I^{2}C interface.

6.4.4.1 Reset

The FDC can be reset by writing to RESET_DEV.RESET_DEV. Any active conversion stops, and all register values return to their default value. This register bit always returns 0b when read.

6.5 Programming

The FDC device uses an I^{2}C interface to access control and data registers.

6.5.1 I^{2}C Interface Specifications

The FDC uses an extended start sequence with I^{2}C for register access. The maximum speed of the I^{2}C interface is 400 kbit/s. This sequence follows the standard I^{2}C 7-bit target address followed by an 8-bit pointer register byte to set the register address. When the ADDR pin is set low, the FDC I^{2}C address is 0x2A; when the ADDR pin is set high, the FDC I^{2}C address is 0x2B. The ADDR pin must not change state after the FDC exits Shutdown Mode.
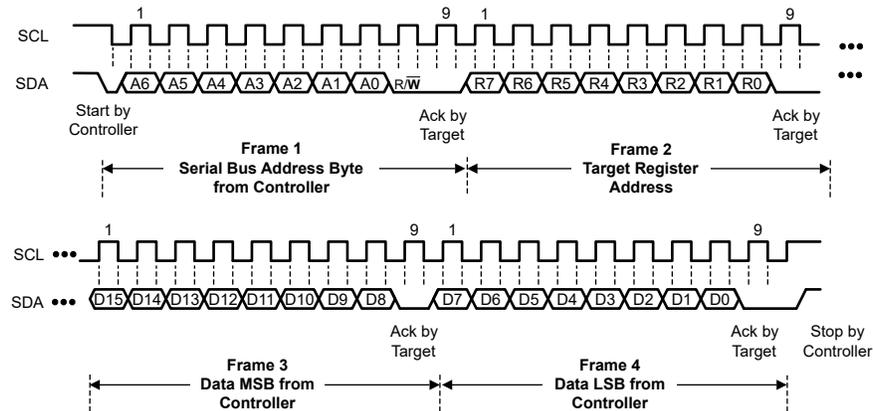
Figure 6-6. I^{2}C Write Register Sequence

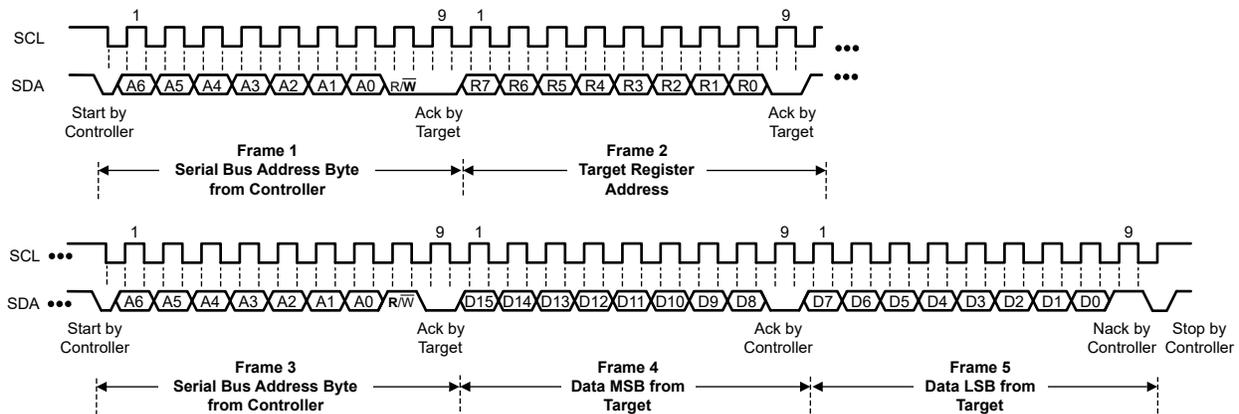**Figure 6-7. I^{2}C Read Register Sequence**

6.6 Register Maps

6.6.1 Register List

Fields indicated with Reserved must be written only with indicated values, otherwise improper device operation may occur. The R/W column indicates the Read-Write status of the corresponding field. A 'R/W' entry indicates read and write capability, a 'R' indicates read-only, and a 'W' indicates write-only.

Figure 6-8. Register List

ADDRESS	NAME	DEFAULT VALUE	DESCRIPTION
0x00	DATA_CH0	0x0000	Channel 0 Conversion Result and status **(FDC2112 / FDC2114 only)**
		0x0000	Channel 0 MSB Conversion Result and status **(FDC2212 / FDC2214 only)**
0x01	DATA_LSB_CH0	0x0000	Channel 0 LSB Conversion Result. Must be read after Register address 0x00 **(FDC2212 / FDC2214 only)**
0x02	DATA_CH1	0x0000	Channel 1 Conversion Result and status **(FDC2112 / FDC2114 only)**
		0x0000	Channel 1 MSB Conversion Result and status **(FDC2212 / FDC2214 only)**
0x03	DATA_LSB_CH1	0x0000	Channel 1 LSB Conversion Result. Must be read after Register address 0x02 **(FDC2212 / FDC2214 only)**
0x04	DATA_CH2	0x0000	Channel 2 Conversion Result and status **(FDC2114 only)**
		0x0000	Channel 2 MSB Conversion Result and status **(FDC2214 only)**
0x05	DATA_LSB_CH2	0x0000	Channel 2 LSB Conversion Result. Must be read after Register address 0x04 **(FDC2214 only)**
0x06	DATA_CH3	0x0000	Channel 3 Conversion Result and status **(FDC2114 only)**
		0x0000	Channel 3 MSB Conversion Result and status **(FDC2214 only)**
0x07	DATA_LSB_CH3	0x0000	Channel 3 LSB Conversion Result. Must be read after Register address 0x06 **(FDC2214 only)**
0x08	RCOUNT_CH0	0x0080	Reference Count setting for Channel 0
0x09	RCOUNT_CH1	0x0080	Reference Count setting for Channel 1
0x0A	RCOUNT_CH2	0x0080	Reference Count setting for Channel 2 **(FDC2114 / FDC2214 only)**
0x0B	RCOUNT_CH3	0x0080	Reference Count setting for Channel 3 **(FDC2114 / FDC2214 only)**
0x0C	OFFSET_CH0	0x0000	Offset value for Channel 0 **(FDC2112 / FDC2114 only)**
0x0D	OFFSET_CH1	0x0000	Offset value for Channel 1 **(FDC2112 / FDC2114 only)**
0x0E	OFFSET_CH2	0x0000	Offset value for Channel 2 **(FDC2114 only)**
0x0F	OFFSET_CH3	0x0000	Offset value for Channel 3 **(FDC2114 only)**
0x10	SETTLECOUNT_CH0	0x0000	Channel 0 Settling Reference Count
0x11	SETTLECOUNT_CH1	0x0000	Channel 1 Settling Reference Count
0x12	SETTLECOUNT_CH2	0x0000	Channel 2 Settling Reference Count **(FDC2114 / FDC2214 only)**
0x13	SETTLECOUNT_CH3	0x0000	Channel 3 Settling Reference Count **(FDC2114 / FDC2214 only)**
0x14	CLOCK_DIVIDERS_CH0	0x0000	Reference divider settings for Channel 0
0x15	CLOCK_DIVIDERS_CH1	0x0000	Reference divider settings for Channel 1
0x16	CLOCK_DIVIDERS_CH2	0x0000	Reference divider settings for Channel 2 **(FDC2114 / FDC2214 only)**
0x17	CLOCK_DIVIDERS_CH3	0x0000	Reference divider settings for Channel 3 **(FDC2114 / FDC2214 only)**
0x18	STATUS	0x0000	Device Status Reporting
0x19	STATUS_CONFIG	0x0000	Device Status Reporting Configuration
0x1A	CONFIG	0x2801	Conversion Configuration
0x1B	MUX_CONFIG	0x020F	Channel Multiplexing Configuration
0x1C	RESET_DEV	0x0000	Reset Device
0x1E	DRIVE_CURRENT_CH0	0x0000	Channel 0 sensor current drive configuration
0x1F	DRIVE_CURRENT_CH1	0x0000	Channel 1 sensor current drive configuration
0x20	DRIVE_CURRENT_CH2	0x0000	Channel 2 sensor current drive configuration **(FDC2114 / FDC2214 only)**
0x21	DRIVE_CURRENT_CH3	0x0000	Channel 3 sensor current drive configuration **(FDC2114 / FDC2214 only)**
0x7E	MANUFACTURER_ID	0x5449	Manufacturer ID
0x7F	DEVICE_ID	0x3054	Device ID **(FDC2112, FDC2114 only)**
		0x3055	Device ID **(FDC2212, FDC2214 only)**

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6.6.2 Address 0x00, DATA_CH0

Figure 6-9. Address 0x00, DATA_CH0

15	14	13	12	11	10	9	8
RESERVED		CH0_ERR_WD	CH0_ERR_AW	DATA0			

7	6	5	4	3	2	1	0
DATA0							

Table 6-10. Address 0x00, DATA_CH0 Field Descriptions

Bit	Field	Type	Reset	Description
15:14	RESERVED	R	00	Reserved.
13	CH0_ERR_WD	R	0	Channel 0 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit.
12	CH0_ERR_AW	R	0	Channel 0 Amplitude Warning. Cleared by reading the bit.
11:0	DATA0 (FDC2112 / FDC2114 only) DATA0[27:16] (FDC2212 / FDC2214 only)	R	0000 0000 0000	Channel 0 Conversion Result

6.6.3 Address 0x01, DATA_LSB_CH0 (FDC2212 / FDC2214 only)

Figure 6-10. Address 0x01, DATA_LSB_CH0

15	14	13	12	11	10	9	8
DATA0							

7	6	5	4	3	2	1	0
DATA0							

Table 6-11. Address 0x01, DATA_CH0 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	DATA0[15:0]	R	0000 0000 0000	Channel 0 Conversion Result

6.6.4 Address 0x02, DATA_CH1

Figure 6-11. Address 0x02, DATA_CH1

15	14	13	12	11	10	9	8
RESERVED		CH1_ERR_WD	CH1_ERR_AW	DATA1			

7	6	5	4	3	2	1	0
DATA1							

Table 6-12. Address 0x02, DATA_CH1 Field Descriptions

Bit	Field	Type	Reset	Description
15:14	RESERVED	R	00	Reserved.
13	CH1_ERR_WD	R	0	Channel 1 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit.
12	CH1_ERR_AW	R	0	Channel 1 Amplitude Warning. Cleared by reading the bit.
11:0	DATA1 (FDC2112 / FDC2114 only) DATA1[27:16] (FDC2212 / FDC2214 only)	R	0000 0000 0000	Channel 1 Conversion Result

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

6.6.5 Address 0x03, DATA_LSB_CH1 (FDC2212 / FDC2214 only)

Figure 6-12. Address 0x03, DATA_LSB_CH1

15	14	13	12	11	10	9	8
DATA1							

7	6	5	4	3	2	1	0
DATA1							

Table 6-13. Address 0x03, DATA_CH1 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	DATA1[15:0]	R	0000 0000 0000	Channel 1 Conversion Result

6.6.6 Address 0x04, DATA_CH2 (FDC2114, FDC2214 only)

Figure 6-13. Address 0x04, DATA_CH2

15	14	13	12	11	10	9	8
RESERVED		CH2_ERR_WD	CH2_ERR_AW	DATA2			

7	6	5	4	3	2	1	0
DATA2							

Table 6-14. Address 0x04, DATA_CH2 Field Descriptions

Bit	Field	Type	Reset	Description
15:14	RESERVED	R	00	Reserved.
13	CH2_ERR_WD	R	0	Channel 2 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit.
12	CH2_ERR_AW	R	0	Channel 2 Amplitude Warning. Cleared by reading the bit.
11:0	DATA2 (FDC2112 / FDC2114 only) DATA2[27:16] (FDC2212 / FDC2214 only)	R	0000 0000 0000	Channel 2 Conversion Result

6.6.7 Address 0x05, DATA_LSB_CH2 (FDC2214 only)

Figure 6-14. Address 0x05, DATA_LSB_CH2

15	14	13	12	11	10	9	8
DATA2							

7	6	5	4	3	2	1	0
DATA2							

Table 6-15. Address 0x05, DATA_CH2 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	DATA2[15:0]	R	0000 0000 0000	Channel 2 Conversion Result

6.6.8 Address 0x06, DATA_CH3 (FDC2114, FDC2214 only)

Figure 6-15. Address 0x06, DATA_CH3

15	14	13	12	11	10	9	8
RESERVED		CH3_ERR_WD	CH3_ERR_AW	DATA3			

7	6	5	4	3	2	1	0

Figure 6-15. Address 0x06, DATA_CH3 (continued)

DATA3

Table 6-16. Address 0x06, DATA_CH3 Field Descriptions

Bit	Field	Type	Reset	Description
15:14	RESERVED	R	00	Reserved.
13	CH3_ERR_WD	R	0	Channel 3 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit.
12	CH3_ERR_AW	R	0	Channel 3 Amplitude Warning. Cleared by reading the bit.
11:0	DATA3 (FDC2112 / FDC2114 only) DATA3[27:16] (FDC2212 / FDC2214 only)	R	0000 0000 0000	Channel 3 Conversion Result

6.6.9 Address 0x07, DATA_LSB_CH3 (FDC2214 only)

Figure 6-16. Address 0x07, DATA_LSB_CH3

15	14	13	12	11	10	9	8
DATA3							
7	6	5	4	3	2	1	0
DATA3							

Table 6-17. Address 0x07, DATA_CH3 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	DATA3[15:0]	R	0000 0000 0000	Channel 3 Conversion Result

6.6.10 Address 0x08, RCOUNT_CH0

Figure 6-17. Address 0x08, RCOUNT_CH0

15	14	13	12	11	10	9	8
CH0_RCOUNT							
7	6	5	4	3	2	1	0
CH0_RCOUNT							

Table 6-18. Address 0x08, RCOUNT_CH0 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH0_RCOUNT	R/W	0000 0000 1000 0000	Channel 0 Reference Count Conversion Interval Time 0x0000-0x00FF: Reserved 0x0100-0xFFFF: Conversion Time (t_{C0}) = (CH0_RCOUNT×16)/ f_{REF0}

6.6.11 Address 0x09, RCOUNT_CH1

Figure 6-18. Address 0x09, RCOUNT_CH1

15	14	13	12	11	10	9	8
CH1_RCOUNT							

7	6	5	4	3	2	1	0
CH1_RCOUNT							

Table 6-19. Address 0x09, RCOUNT_CH1 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH1_RCOUNT	R/W	0000 0000 1000 0000	Channel 1 Reference Count Conversion Interval Time 0x0000-0x00FF: Reserved 0x0100-0xFFFF: Conversion Time (t_{C1})= (CH1_RCOUNT×16)/ f_{REF1}

6.6.12 Address 0x0A, RCOUNT_CH2 (FDC2114, FDC2214 only)

Figure 6-19. Address 0x0A, RCOUNT_CH2

15	14	13	12	11	10	9	8
CH2_RCOUNT							

7	6	5	4	3	2	1	0
CH2_RCOUNT							

Table 6-20. Address 0x0A, RCOUNT_CH2 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH2_RCOUNT	R/W	0000 0000 1000 0000	Channel 2 Reference Count Conversion Interval Time 0x0000-0x00FF: Reserved 0x0100-0xFFFF: Conversion Time (t_{C2})= (CH2_RCOUNT×16)/ f_{REF2}

6.6.13 Address 0x0B, RCOUNT_CH3 (FDC2114, FDC2214 only)

Figure 6-20. Address 0x0B, RCOUNT_CH3

15	14	13	12	11	10	9	8
CH3_RCOUNT							

7	6	5	4	3	2	1	0
CH3_RCOUNT							

Table 6-21. Address 0x0B, RCOUNT_CH3 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH3_RCOUNT	R/W	0000 0000 1000 0000	Channel 3 Reference Count Conversion Interval Time 0x0000-0x00FF: Reserved 0x0100-0xFFFF: Conversion Time (t_{C3})= (CH3_RCOUNT×16)/ f_{REF3}

6.6.14 Address 0x0C, OFFSET_CH0 (FDC21112 / FDC2114 only)

Figure 6-21. Address 0x0C, CH0_OFFSET

15	14	13	12	11	10	9	8
CH0_OFFSET							

7	6	5	4	3	2	1	0
CH0_OFFSET							

Table 6-22. CH0_OFFSET Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH0_OFFSET	R/W	0000 0000 0000 0000	Channel 0 Conversion Offset. f_{OFFSET_0} = (CH0_OFFSET/ 2^{16})*f_{REF0}

6.6.15 Address 0x0D, OFFSET_CH1 (FDC21112 / FDC2114 only)

Figure 6-22. Address 0x0D, OFFSET_CH1

15	14	13	12	11	10	9	8
CH1_OFFSET							

7	6	5	4	3	2	1	0
CH1_OFFSET							

Table 6-23. Address 0x0D, OFFSET_CH1 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH1_OFFSET	R/W	0000 0000 0000 0000	Channel 1 Conversion Offset. f_{OFFSET_1} = (CH1_OFFSET/ 2^{16})*f_{REF1}

6.6.16 Address 0x0E, OFFSET_CH2 (FDC2114 only)

Figure 6-23. Address 0x0E, OFFSET_CH2

15	14	13	12	11	10	9	8
CH2_OFFSET							

7	6	5	4	3	2	1	0
CH2_OFFSET							

Table 6-24. Address 0x0E, OFFSET_CH2 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH2_OFFSET	R/W	0000 0000 0000 0000	Channel 2 Conversion Offset. f_{OFFSET_2} = (CH2_OFFSET/ 2^{16})*f_{REF2}

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

6.6.17 Address 0x0F, OFFSET_CH3 (FDC2114 only)

Figure 6-24. Address 0x0F, OFFSET_CH3

15	14	13	12	11	10	9	8
CH3_OFFSET							

7	6	5	4	3	2	1	0
CH3_OFFSET							

Table 6-25. Address 0x0F, OFFSET_CH3 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH3_OFFSET	R/W	0000 0000 0000 0000	Channel 3 Conversion Offset. f_{OFFSET_3} = (CH3_OFFSET/ 2^{16})*f_{REF3}

6.6.18 Address 0x10, SETTLECOUNT_CH0

Figure 6-25. Address 0x10, SETTLECOUNT_CH0

15	14	13	12	11	10	9	8
CH0_SETTLECOUNT							

7	6	5	4	3	2	1	0
CH0_SETTLECOUNT							

Table 6-26. Address 0x11, SETTLECOUNT_CH0 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH0_SETTLECOUNT	R/W	0000 0000 0000 0000	Channel 0 Conversion Settling The FDC uses this settling time to allow the LC sensor to stabilize before initiation of a conversion on Channel 0. If the amplitude has not settled prior to the conversion start, an Amplitude warning is generated if reporting of this type of warning is enabled. 0x0000: Settle Time (t_{S0})= 32 ÷ f_{REF0} 0x0001: Settle Time (t_{S0})= 32 ÷ f_{REF0} 0x0002 - 0xFFFF: Settle Time (t_{S0})= (CH0_SETTLECOUNT×16) ÷ f_{REF0}

6.6.19 Address 0x11, SETTLECOUNT_CH1

Figure 6-26. Address 0x11, SETTLECOUNT_CH1

15	14	13	12	11	10	9	8
CH1_SETTLECOUNT							

7	6	5	4	3	2	1	0
CH1_SETTLECOUNT							

Table 6-27. Address 0x12, SETTLECOUNT_CH1 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH1_SETTLECOUNT	R/W	0000 0000 0000 0000	Channel 1 Conversion Settling The FDC uses this settling time to allow the LC sensor to stabilize before initiation of a conversion on a Channel 1. If the amplitude has not settled prior to the conversion start, an Amplitude warning is generated if reporting of this type of warning is enabled. 0x0000: Settle Time (t_{S1})= 32 ÷ f_{REF1} 0x0001: Settle Time (t_{S1})= 32 ÷ f_{REF1} 0x0002 - 0xFFFF: Settle Time (t_{S1})= (CH1_SETTLECOUNT×16) ÷ f_{REF1}

6.6.20 Address 0x12, SETTLECOUNT_CH2 (FDC2114, FDC2214 only)

Figure 6-27. Address 0x12, SETTLECOUNT_CH2

15	14	13	12	11	10	9	8
			CH2_SETTLECOUNT				

7	6	5	4	3	2	1	0
			CH2_SETTLECOUNT				

Table 6-28. Address 0x12, SETTLECOUNT_CH2 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH2_SETTLECOUNT	R/W	0000 0000 0000 0000	Channel 2 Conversion Settling The FDC uses this settling time to allow the LC sensor to stabilize before initiation of a conversion on Channel 2. If the amplitude has not settled prior to the conversion start, an Amplitude warning is generated if reporting of this type of warning is enabled. 0x0000: Settle Time (t_{S2}) = 32 ÷ f_{REF2} 0x0001: Settle Time (t_{S2}) = 32 ÷ f_{REF2} 0x0002 - 0xFFFF: Settle Time (t_{S2})= (CH2_SETTLECOUNT×16) ÷ f_{REF2}

6.6.21 Address 0x13, SETTLECOUNT_CH3 (FDC2114, FDC2214 only)

Figure 6-28. Address 0x13, SETTLECOUNT_CH3

15	14	13	12	11	10	9	8
			CH3_SETTLECOUNT				

7	6	5	4	3	2	1	0
			CH3_SETTLECOUNT				

Table 6-29. Address 0x13, SETTLECOUNT_CH3 Field Descriptions

Bit	Field	Type	Reset	Description
15:0	CH3_SETTLECOUNT	R/W	0000 0000 0000 0000	Channel 3 Conversion Settling The FDC uses this settling time to allow the LC sensor to stabilize before initiation of a conversion on Channel 3. If the amplitude has not settled prior to the conversion start, an Amplitude warning is generated if reporting of this type of warning is enabled 0x0000: Settle Time (t_{S3}) = 32 ÷ f_{REF3} 0x0001: Settle Time (t_{S3}) = 32 ÷ f_{REF3} 0x0002 - 0xFFFF: Settle Time (t_{S3})= (CH3_SETTLECOUNT×16) ÷ f_{REF3}

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

6.6.22 Address 0x14, CLOCK_DIVIDERS_CH0

Figure 6-29. Address 0x14, CLOCK_DIVIDERS_CH0

15	14	13	12	11	10	9	8
RESERVED		CH0_FIN_SEL		RESERVED		CH0_FREF_DIVIDER	

7	6	5	4	3	2	1	0
CH0_FREF_DIVIDER							

Table 6-30. Address 0x14, CLOCK_DIVIDERS_CH0 Field Descriptions

Bit	Field	Type	Reset	Description
15:14	RESERVED	R/W	00	Reserved. Set to b00.
13:12	CH0_FIN_SEL	R/W	00	Channel 0 Sensor frequency select for differential sensor configuration: b01: divide by 1. Choose for sensor frequencies between 0.01MHz and 8.75MHz b10: divide by 2. Choose for sensor frequencies between 5MHz and 10MHz for single-ended sensor configuration: b10: divide by 2. Choose for sensor frequencies between 0.01MHz and 10MHz
11:10	RESERVED	R/W	00	Reserved. Set to b00.
9:0	CH0_FREF_DIVIDER	R/W	00 0000 0000	Channel 0 Reference Divider Sets the divider for Channel 0 reference. Use this to scale the maximum conversion frequency. b00'0000'0000: Reserved. Do not use. CH0_FREF_DIVIDER≥b00'0000'0001: $f_{REF0} = f_{CLK}/$CH0_FREF_DIVIDER

6.6.23 Address 0x15, CLOCK_DIVIDERS_CH1

Figure 6-30. Address 0x15, CLOCK_DIVIDERS_CH1

15	14	13	12	11	10	9	8
RESERVED		CH1_FIN_SEL		RESERVED		CH1_FREF_DIVIDER	

7	6	5	4	3	2	1	0
CH1_FREF_DIVIDER							

Table 6-31. Address 0x15, CLOCK_DIVIDERS_CH1 Field Descriptions

Bit	Field	Type	Reset	Description
15:14	RESERVED	R/W	00	Reserved. Set to b00.
13:12	CH1_FIN_SEL	R/W	0000	Channel 1 Sensor frequency select for differential sensor configuration: b01: divide by 1. Choose for sensor frequencies between 0.01MHz and 8.75MHz b10: divide by 2. Choose for sensor frequencies between 5MHz and 10MHz for single-ended sensor configuration: b10: divide by 2. Choose for sensor frequencies between 0.01MHz and 10MHz
11:10	RESERVED	R/W	00	Reserved. Set to b00.
9:0	CH1_FREF_DIVIDER	R/W	00 0000 0000	Channel 1 Reference Divider Sets the divider for Channel 1 reference. Use this to scale the maximum conversion frequency. b00'0000'0000: Reserved. Do not use. CH1_FREF_DIVIDER≥ b00'0000'0001: $f_{REF1} = f_{CLK}/$CH1_FREF_DIVIDER

6.6.24 Address 0x16, CLOCK_DIVIDERS_CH2 (FDC2114, FDC2214 only)

Figure 6-31. Address 0x16, CLOCK_DIVIDERS_CH2

15	14	13	12	11	10	9	8
RESERVED		CH2_FIN_SEL		RESERVED		CH2_FREF_DIVIDER	

7	6	5	4	3	2	1	0
CH2_FREF_DIVIDER							

Table 6-32. Address 0x16, CLOCK_DIVIDERS_CH2 Field Descriptions

Bit	Field	Type	Reset	Description
15:14	RESERVED	R/W	00	Reserved. Set to b00.
13:12	CH2_FIN_SEL	R/W	0000	Channel 2 Sensor frequency select for differential sensor configuration: b01: divide by 1. Choose for sensor frequencies between 0.01MHz and 8.75MHz b10: divide by 2. Choose for sensor frequencies between 5MHz and 10MHz for single-ended sensor configuration: b10: divide by 2. Choose for sensor frequencies between 0.01MHz and 10MHz
11:10	RESERVED	R/W	00	Reserved. Set to b00.
9:0	CH2_FREF_DIVIDER	R/W	00 0000 0000	Channel 2 Reference Divider Sets the divider for Channel 2 reference. Use this to scale the maximum conversion frequency. b00'0000'0000: Reserved. Do not use. CH2_FREF_DIVIDER ≥ b00'0000'0001: $f_{REF2} = f_{CLK}/$CH2_FREF_DIVIDER

6.6.25 Address 0x17, CLOCK_DIVIDERS_CH3 (FDC2114, FDC2214 only)

Figure 6-32. Address 0x17, CLOCK_DIVIDERS_CH3

15	14	13	12	11	10	9	8
RESERVED		CH3_FIN_SEL		RESERVED		CH3_FREF_DIVIDER	

7	6	5	4	3	2	1	0
CH3_FREF_DIVIDER							

Table 6-33. Address 0x17, CLOCK_DIVIDERS_CH3

Bit	Field	Type	Reset	Description
15:14	RESERVED	R/W	00	Reserved. Set to b00.
13:12	CH3_FIN_SEL	R/W	0000	Channel 3 Sensor frequency select for differential sensor configuration: b01: divide by 1. Choose for sensor frequencies between 0.01MHz and 8.75MHz b10: divide by 2. Choose for sensor frequencies between 5MHz and 10MHz for single-ended sensor configuration: b10: divide by 2. Choose for sensor frequencies between 0.01MHz and 10MHz
11:10	RESERVED	R/W	00	Reserved. Set to b00.
9:0	CH3_FREF_DIVIDER	R/W	00 0000 0000	Channel 3 Reference Divider Sets the divider for Channel 3 reference. Use this to scale the maximum conversion frequency. b00'0000'0000: reserved CH3_FREF_DIVIDER ≥ b00'0000'0001: $f_{REF3} = f_{CLK}/$CH3_FREF_DIVIDER

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

6.6.26 Address 0x18, STATUS

Figure 6-33. Address 0x18, STATUS

15	14	13	12	11	10	9	8
ERR_CHAN		RESERVED		ERR_WD	RESERVED		

7	6	5	4	3	2	1	0
RESERVED	DRDY	RESERVED		CH0_UNREAD CONV	CH1_ UNREADCONV	CH2_ UNREADCONV	CH3_ UNREADCONV

Table 6-34. Address 0x18, STATUS Field Descriptions

Bit	Field	Type	Reset	Description
15:14	ERR_CHAN	R	00	Error Channel Indicates which channel has generated a Flag or Error. When flagged, any reported error is latched and maintained until either the STATUS register or the DATA_CHx register corresponding to the Error Channel is read. b00: Channel 0 is source of flag or error. b01: Channel 1 is source of flag or error. b10: Channel 2 is source of flag or error (FDC2114, FDC2214 only). b11: Channel 3 is source of flag or error (FDC2114, FDC2214 only).
13:12	RESERVED	R	00	Reserved
11	ERR_WD	R	0	Watchdog Timeout Error b0: No Watchdog Timeout error was recorded since the last read of the STATUS register. b1: An active channel has generated a Watchdog Timeout error. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this error.
10	ERR_AHW	R	0	Amplitude High Warning b0: No Amplitude High warning was recorded since the last read of the STATUS register. b1: An active channel has generated an Amplitude High warning. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this warning.
9	ERR_ALW	R	0	Amplitude Low Warning b0: No Amplitude Low warning was recorded since the last read of the STATUS register. b1: An active channel has generated an Amplitude Low warning. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this warning.
8:7	RESERVED	R	00	Reserved
6	DRDY	R	0	Data Ready Flag. b0: No new conversion result was recorded in the STATUS register. b1: A new conversion result is ready. When in Single Channel Conversion, this indicates a single conversion is available. When in sequential mode, this indicates that a new conversion result for all active channels is now available.
3	CH0_UNREADCONV	R	0	Channel 0 Unread Conversion b0: No unread conversion is present for Channel 0. b1: An unread conversion is present for Channel 0. Read Register DATA_CH0 to retrieve conversion results.
2	CH1_ UNREADCONV	R	0	Channel 1 Unread Conversion b0: No unread conversion is present for Channel 1. b1: An unread conversion is present for Channel 1. Read Register DATA_CH1 to retrieve conversion results.
1	CH2_ UNREADCONV	R	0	Channel 2 Unread Conversion b0: No unread conversion is present for Channel 2. b1: An unread conversion is present for Channel 2. Read Register DATA_CH2 to retrieve conversion results (FDC2114, FDC2214 only)
0	CH3_ UNREADCONV	R	0	Channel 3 Unread Conversion b0: No unread conversion is present for Channel 3. b1: An unread conversion is present for Channel 3. Read Register DATA_CH3 to retrieve conversion results (FDC2114, FDC2214 only)

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Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

6.6.27 Address 0x19, ERROR_CONFIG

Figure 6-34. Address 0x19, ERROR_CONFIG

15	14	13	12	11	10	9	8
RESERVED		WD_ERR2OUT	AH_WARN2OUT	AL_WARN2OUT	RESERVED		

7	6	5	4	3	2	1	0
RESERVED		WD_ERR2INT	RESERVED				DRDY_2INT

Table 6-35. Address 0x19, ERROR_CONFIG

Bit	Field	Type	Reset	Description
15:14	RESERVED	R/W	00	Reserved (set to b000)
13	WD_ERR2OUT	R/W	0	Watchdog Timeout Error to Output Register b0: Do not report Watchdog Timeout errors in the DATA_CHx registers. b1: Report Watchdog Timeout errors in the DATA_CHx.CHx_ERR_WD register field corresponding to the channel that generated the error.
12	AH_WARN2OUT	R/W	0	Amplitude High Warning to Output Register b0:Do not report Amplitude High warnings in the DATA_CHx registers. b1: Report Amplitude High warnings in the DATA_CHx.CHx_ERR_AW register field corresponding to the channel that generated the warning.
11	AL_WARN2OUT	R/W	0	Amplitude Low Warning to Output Register b0: Do not report Amplitude Low warnings in the DATA_CHx registers. b1: Report Amplitude High warnings in the DATA_CHx.CHx_ERR_AW register field corresponding to the channel that generated the warning.
10:6	RESERVED	R/W	0 0000	Reserved (set to b0 0000)
5	WD_ERR2INT	R/W	0	Watchdog Timeout Error to INTB b0: Do not report Under-range errors by asserting INTB pin and STATUS register. b1: Report Watchdog Timeout errors by asserting INTB pin and updating STATUS.ERR_WD register field.
4:1	Reserved	R/W	0000	Reserved (set to b000)
0	DRDY_2INT	R/W	0	Data Ready Flag to INTB b0: Do not report Data Ready Flag by asserting INTB pin and STATUS register. b1: Report Data Ready Flag by asserting INTB pin and updating STATUS. DRDY register field.

6.6.28 Address 0x1A, CONFIG

Figure 6-35. Address 0x1A, CONFIG

15	14	13	12	11	10	9	8
ACTIVE_CHAN		SLEEP_MODE_EN	RESERVED	SENSOR_ACTIVATE_SEL	RESERVED	REF_CLK_SRC	RESERVED

7	6	5	4	3	2	1	0
INTB_DIS	HIGH_CURRENT_DRV	RESERVED					

Table 6-36. Address 0x1A, CONFIG Field Descriptions

Bit	Field	Type	Reset	Description
15:14	ACTIVE_CHAN	R/W	00	Active channel selection Selects channel for continuous conversions when MUX_CONFIG.SEQUENTIAL is 0. b00: Perform continuous conversions on Channel 0 b01: Perform continuous conversions on Channel 1 b10: Perform continuous conversions on Channel 2 (FDC2114, FDC2214 only) b11: Perform continuous conversions on Channel 3 (FDC2114, FDC2214 only)
13	SLEEP_MODE_EN	R/W	1	Sleep mode enable Enter or exit low power sleep mode. b0: Device is active. b1: Device is in sleep mode.
12	RESERVED	R/W	0	Reserved. **Set to b1.**
11	SENSOR_ACTIVATE_SEL	R/W	1	Sensor activation mode selection. Set the mode for sensor initialization. b0: Full current activation mode – the FDC drives the maximum sensor current for a shorter sensor activation time. b1: Low power activation mode – the FDC uses the value programmed in DRIVE_CURRENT_CHx during sensor activation to minimize power consumption.
10	RESERVED	R/W	0	Reserved. **Set to b1.**
9	REF_CLK_SRC	R/W	0	Select Reference Frequency Source b0: Use Internal oscillator as reference frequency b1: Reference frequency is provided from CLKIN pin.
8	RESERVED	R/W	0	Reserved. Set to b0.
7	INTB_DIS	R/W	0	INTB Disable b0: Asserts INTB pin when status register updates. b1: Does not assert INTB pin when status register updates
6	HIGH_CURRENT_DRV	R/W	0	High Current Sensor Drive b0: The FDC drives all channels with normal sensor current (1.5mA maximum). b1: The FDC drives channel 0 with current >1.5mA. This mode is not supported if AUTOSCAN_EN = b1 (multi-channel mode)
5:0	RESERVED	R/W	00 0001	Reserved Set to b00'0001

6.6.29 Address 0x1B, MUX_CONFIG

Figure 6-36. Address 0x1B, MUX_CONFIG

15	14	13	12	11	10	9	8
AUTOSCAN_EN	RR_SEQUENCE		RESERVED				

7	6	5	4	3	2	1	0
RESERVED					DEGLITCH		

Table 6-37. Address 0x1B, MUX_CONFIG Field Descriptions

Bit	Field	Type	Reset	Description
15	AUTOSCAN_EN	R/W	0	Auto-Scan mode enable b0: Continuous conversion on the single channel selected by CONFIG.ACTIVE_CHAN register field. b1: Auto-Scan conversions as selected by MUX_CONFIG.RR_SEQUENCE register field.
14:13	RR_SEQUENCE	R/W	00	Auto-Scan sequence configuration Configure multiplexing channel sequence. The FDC performs a single conversion on each channel in the sequence selected, and then restart the sequence continuously. b00: Ch0, Ch1 b01: Ch0, Ch1, Ch2 (FDC2114, FDC2214 only) b10: Ch0, Ch1, Ch2, Ch3 (FDC2114, FDC2214 only) b11: Ch0, Ch1
12:3	RESERVED	R/W	00 0100 0001	Reserved. Must be set to 00 0100 0001
2:0	DEGLITCH	R/W	111	Input deglitch filter bandwidth. Select the lowest setting that exceeds the oscillation tank oscillation frequency. b001: 1MHz b100: 3.3MHz b101: 10MHz b111: 33MHz

6.6.30 Address 0x1C, RESET_DEV

Figure 6-37. Address 0x1C, RESET_DEV

15	14	13	12	11	10	9	8
RESET_DEV	RESERVED				OUTPUT_GAIN		RESERVED

7	6	5	4	3	2	1	0
RESERVED							

Table 6-38. Address 0x1C, RESET_DEV Field Descriptions

Bit	Field	Type	Reset	Description
15	RESET_DEV	R/W	0	Device Reset Write b1 to reset the device. Will always readback 0.
14:11	RESERVED	R/W	0000	Reserved. Set to b0000
10:9	OUTPUT_GAIN	R/W	00	Output gain control (FDC2112, FDC2114 only) 00: Gain =1 (0 bits shift) 01: Gain = 4 (2 bits shift) 10: Gain = 8 (3 bits shift) 11: Gain = 16 (4 bits shift)
8:0	RESERVED	R/W	0 0000 0000	Reserved, Set to b0 0000 0000

6.6.31 Address 0x1E, DRIVE_CURRENT_CH0

Figure 6-38. Address 0x1E, DRIVE_CURRENT_CH0

15	14	13	12	11	10	9	8
		CH0_IDRIVE				RESERVED	

7	6	5	4	3	2	1	0
				RESERVED			

Table 6-39. Address 0x1E, DRIVE_CURRENT_CH0 Field Descriptions

Bit	Field	Type	Reset	Description
15:11	CH0_IDRIVE	R/W	0000 0	Channel 0 Sensor drive current This field defines the Drive Current used during the settling + conversion time of Channel 0 sensor clock. Set such that 1.2V ≤ sensor oscillation amplitude (pk) ≤ 1.8V 00000: 0.016mA 00001: 0.018mA 00010: 0.021mA 00011: 0.025mA 00100: 0.028mA 00101: 0.033mA 00110: 0.038mA 00111: 0.044mA 01000: 0.052mA 01001: 0.060mA 01010: 0.069mA 01011: 0.081mA 01100: 0.093mA 01101: 0.108mA 01110: 0.126mA 01111: 0.146mA 10000: 0.169mA 10001: 0.196mA 10010: 0.228mA 10011: 0.264mA 10100: 0.307mA 10101: 0.356mA 10110: 0.413mA 10111: 0.479mA 11000: 0.555mA 11001: 0.644mA 11010: 0.747mA 11011: 0.867mA 11100: 1.006mA 11101: 1.167mA 11110: 1.354mA 11111: 1.571mA
10:0	RESERVED	–	000 0000 0000	Reserved

6.6.32 Address 0x1F, DRIVE_CURRENT_CH1

Figure 6-39. Address 0x1F, DRIVE_CURRENT_CH1

15	14	13	12	11	10	9	8
CH1_IDRIVE					RESERVED		

7	6	5	4	3	2	1	0
RESERVED							

Table 6-40. Address 0x1F, DRIVE_CURRENT_CH1 Field Descriptions

Bit	Field	Type	Reset	Description
15:11	CH1_IDRIVE	R/W	0000 0	Channel 1 Sensor drive current This field defines the drive current used during the settling + conversion time of Channel 1 sensor clock. Set such that 1.2V ≤ sensor oscillation amplitude (pk) ≤ 1.8V 00000: 0.016mA 00001: 0.018mA 00010: 0.021mA ... 11111: 1.571mA
10:0	RESERVED	-	000 0000 0000	Reserved

6.6.33 Address 0x20, DRIVE_CURRENT_CH2 (FDC2114 / FDC2214 only)

Figure 6-40. Address 0x20, DRIVE_CURRENT_CH2

15	14	13	12	11	10	9	8
CH2_IDRIVE					RESERVED		

7	6	5	4	3	2	1	0
RESERVED							

Table 6-41. Address 0x20, DRIVE_CURRENT_CH2 Field Descriptions

Bit	Field	Type	Reset	Description
15:11	CH2_IDRIVE	R/W	0000 0	Channel 2 Sensor drive current This field defines the drive current to be used during the settling + conversion time of Channel 2 sensor clock. Set such that 1.2V ≤ sensor oscillation amplitude (pk) ≤ 1.8V 00000: 0.016mA 00001: 0.018mA 00010: 0.021mA ... 11111: 1.571mA
10:0	RESERVED	–	000 0000 0000	Reserved

6.6.34 Address 0x21, DRIVE_CURRENT_CH3 (FDC2114 / FDC2214 only)

Figure 6-41. Address 0x21, DRIVE_CURRENT_CH3

15	14	13	12	11	10	9	8
CH3_IDRIVE					RESERVED		

7	6	5	4	3	2	1	0
RESERVED							

Table 6-42. DRIVE_CURRENT_CH3 Field Descriptions

Bit	Field	Type	Reset	Description
15:11	CH3_IDRIVE	R/W	0000 0	Channel 3 Sensor drive current This field defines the drive current to be used during the settling + conversion time of Channel 3 sensor clock. Set such that 1.2V ≤ sensor oscillation amplitude (pk) ≤ 1.8V 00000: 0.016mA 00001: 0.018mA 00010: 0.021mA ... 11111: 1.571mA
10:0	RESERVED	–	000 0000 0000	Reserved

6.6.35 Address 0x7E, MANUFACTURER_ID

Figure 6-42. Address 0x7E, MANUFACTURER_ID

15	14	13	12	11	10	9	8
MANUFACTURER_ID							

7	6	5	4	3	2	1	0
MANUFACTURER_ID							

Table 6-43. Address 0x7E, MANUFACTURER_ID Field Descriptions

Bit	Field	Type	Reset	Description
15:0	MANUFACTURER_ID	R	0101 0100 0100 1001	Manufacturer ID = 0x5449

6.6.36 Address 0x7F, DEVICE_ID

Figure 6-43. Address 0x7F, DEVICE_ID

7	6	5	4	3	2	1	0
DEVICE_ID							

Table 6-44. Address 0x7F, DEVICE_ID Field Descriptions

Bit	Field	Type	Reset	Description
7:0	DEVICE_ID	R	0011 0000 0101 0100	Device ID 0x3054 (FDC2112, FDC2114 only) 0x3055 (FDC2212, FDC2214 only)

7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Application Information

7.1.1 Sensor Configuration

The FDC supports two sensor configurations. Both configurations use an LC tank to set the frequency of oscillation. A typical choice is an 18-µH shielded SMD inductor in parallel with a 33pF capacitor, which result in a 6.5MHz oscillation frequency. In the single-ended configuration in Figure 7-1, a conductive plate is connected IN0A. Together with a target object, the conductive plate forms a variable capacitor.
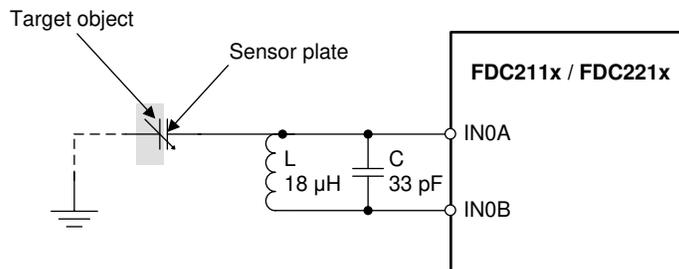
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Figure 7-1. Single-Ended Sensor Configuration

In the differential sensor configuration in Figure 7-2, one conductive plate is connected to IN0A, and a second conductive plate is connected to IN0B. Together, they form a variable capacitor. When using an single-ended sensor configuration, set CHx_FIN_SEL to b10 (divide by 2).
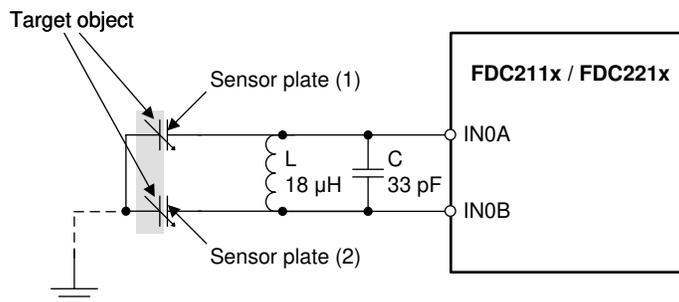
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Figure 7-2. Differential Sensor Configuration

The single-ended configuration allows higher sensing range than the differential configuration for a given total sensor plate area. In applications in which high sensitivity at close proximity is desired, the differential configuration performs better than the single-ended configuration.

7.1.2 Shield

in order to minimize interference from external objects, some applications require an additional plate which acts as a shield. The shield can either be:

- actively driven shield: The shield is a buffered signal of the INxA pin. The signal is buffered by an external amplifier with a gain of 1.
- passive shield: The shield is connected to GND. Adding a passive shield decreases sensitivity of the sensor, but is dependent on the distance between the distance between the sensing plate and the shield. Adjust the distance between the sensing plate and the shield to achieve the required sensitivity.

7.1.3 Power-Cycled Applications

For applications which do not require high sample rates or maximum conversion resolution, the total active conversion time of the FDC can be minimized to reduce power consumption. This can be done by either by using sleep mode or shutdown mode during times in which conversions are not required (see *Device Functional Modes*).

As an example, for an application which only needs 10 samples per second with a resolution of 16 bits can utilize the low-power modes. The sensor requires SETTLECOUNT = 16 and IDRIVE of 01111b (0.146mA). Given FREF = 40MHz and RCOUNT = 4096 will provide the resolution required. This corresponds to 4096 × 16 × 10 / 40MHz → 16.4ms of active conversion time per second. Start-up time and channel switch delay account for an additional 0.34ms. For the remainder of the time, the device can be in sleep mode: Therefore, the average current is 19.4ms * 3.6mA active current + 980.6ms of 35µA of sleep current, which is approximately 104.6µA of average supply current. Sleep mode retains register settings and therefore requires less I^2C writes to wake up the FDC than shutdown mode.

Greater current savings can be realized by use of shutdown mode during inactive periods. In shutdown mode, device configuration is not retained, so the device must be configured for each sample. For this example, configuring each sample takes approximately 1.2ms (13 registers × 92.5 µs per register). The total active time is 20.6ms. The average current is 20ms × 3.6mA active current + 980ms × 2µA of shutdown current, which is approximately 75µA of average supply current.

For further information on power-cycled applications, refer to *Power Reduction Techniques for the FDC2214/2212/2114/2112 in Capacitive Sensing Applications*.

7.1.4 Inductor Self-Resonant Frequency

Every inductor has a distributed parasitic capacitance, which is dependent on construction and geometry. At the self-resonant frequency (SRF), the reactance of the inductor cancels the reactance of the parasitic capacitance. Above the SRF, the inductor electrically appears to be a capacitor. The parasitic capacitance is not well-controlled or stable, therefore TI recommends $f_{SENSOR} < 0.8 \times f_{SR}$.
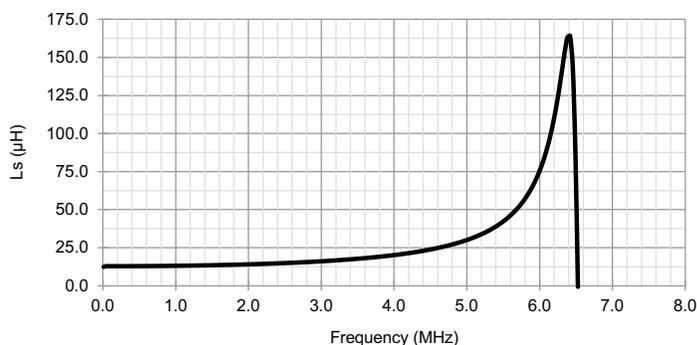
Figure 7-3. Example Coil Inductance vs Frequency

The example inductor in Figure 7-3, has a SRF at 6.38MHz; therefore, the inductor must not be operated above 0.8 × 6.38MHz, or 5.1MHz.

7.1.5 Application Curves for Proximity Sensing

Common test conditions (unless specified otherwise): Sensor capacitor: 1 layer, 20.9 × 13.9mm, Bourns CMH322522-180KL sensor inductor with L=18µH and 33pF 1% COG/NP0 Target: Grounded aluminum plate (176 × 123mm), Channel = Channel 0 (continuous mode) CLKIN = 40MHz, CHx_FIN_SEL = b10, CHx_FREF_DIVIDER = b00 0000 0001 CH0_RCOUNT = 0xFFFF, SETTLECOUNT_CH0 = 0x0100, DRIVE_CURRENT_CH0 = 0x7800
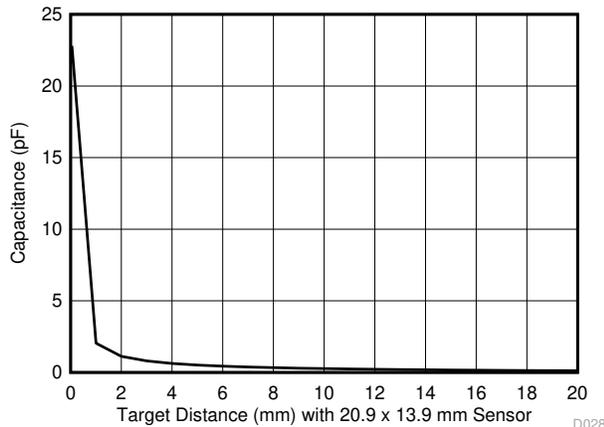
Figure 7-4. FDC2212 / FDC2214: Capacitance vs Target Distance (0mm to 20mm)
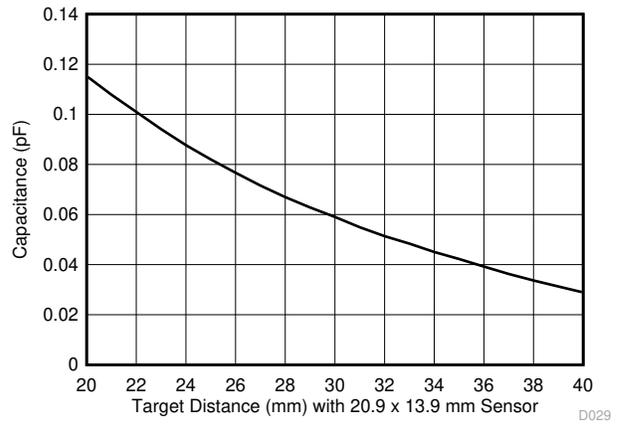
Figure 7-5. FDC2112 / FDC2114: Capacitance vs Target Distance (20mm to 40mm)
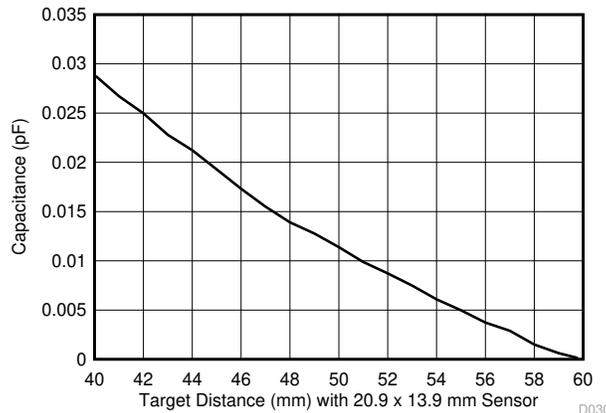
Figure 7-6. FDC2212 / FDC2214: Capacitance vs Target Distance (40mm to 60mm)

7.2 Typical Application

The FDC can be used to measure liquid level in non-conductive containers. Due to very high excitation rate capability, the FDC is able to measure soapy water, ink, soap, and other conductive liquids. Capacitive sensors can be attached to the outside of the container or be located remotely from the container, allowing for contactless measurements.

The working principle is based on a ratiometric measurement; Figure 7-7 shows a possible system implementation which uses three electrodes. The level electrode provides a capacitance value proportional to the liquid level. The reference environmental electrode and the reference liquid electrode are used as references. The reference liquid electrode accounts for the liquid dielectric constant and its variation, while the reference environmental electrode is used to compensate for any other environmental variations that are not due to the liquid itself. Note that the reference environmental electrode and the reference liquid electrode are the same physical size (hREF).

For this application, single-ended measurements on the active channels are appropriate, as the tank is grounded. Use Equation 7 to determine the liquid level from the measured capacitances:

$$Level = h_{ref} \frac{C_{Lev} - C_{Lev}(0)}{C_{RL} - C_{RE}}$$

(7)

where

- C_{RE} is the capacitance of the reference environmental electrode,
- C_{RL} is the capacitance of the reference liquid electrode,
- C_{Lev} is the current value of the capacitance measured at the level electrode sensor,
- $C_{Lev}(0)$ is the capacitance of the Level electrode when the container is empty, and
- h_{REF} is the height in the desired units of the container or liquid reference electrodes.

The ratio between the capacitance of the level and the reference electrodes allows simple calculation of the liquid level inside the container itself. Very high sensitivity values (that is, many LSB/mm) can be obtained due to the high resolution of the FDC2x1x, even when the sensors are located remotely from the container. Note that this approach assumes that the container has a uniform cross section from top to bottom, so that each incremental increase or decrease in the liquid represents a change in volume that is directly related to the height of the liquid.

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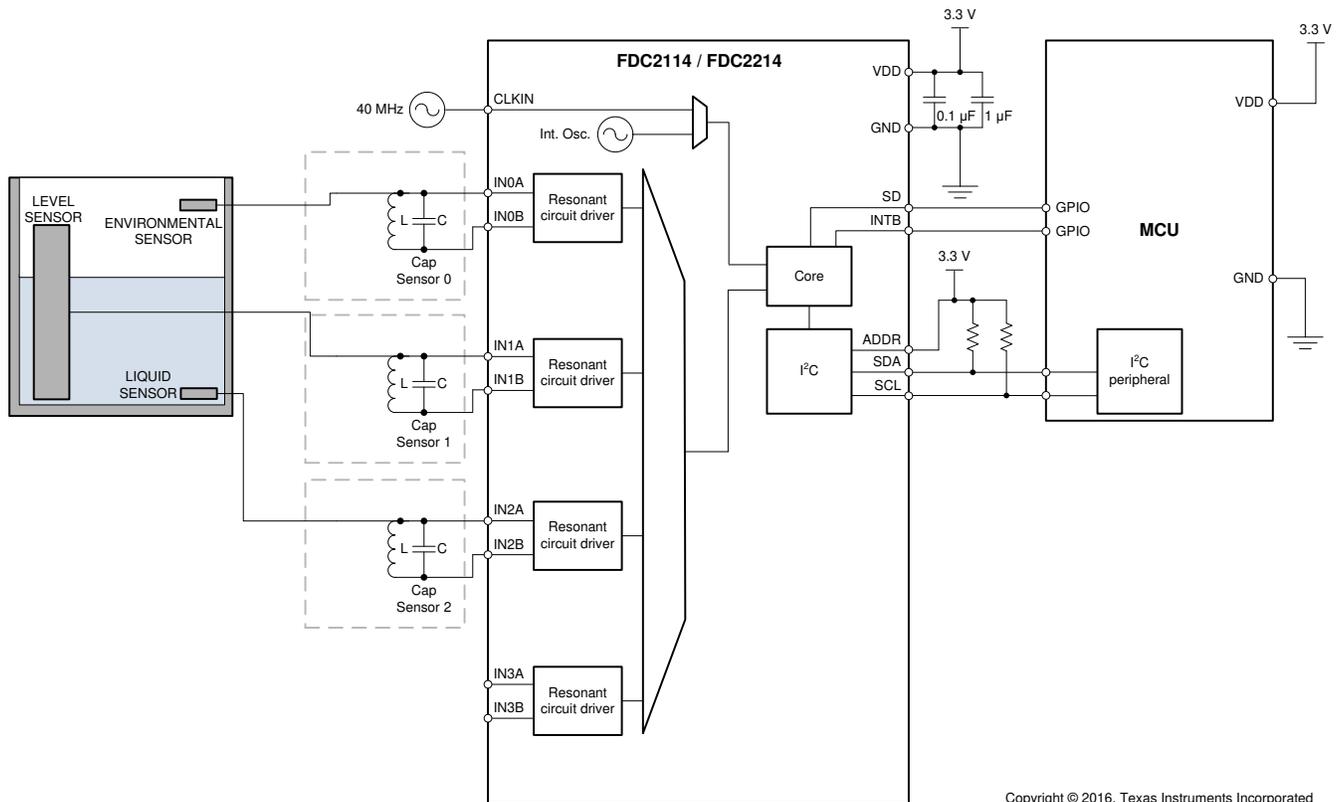
Figure 7-7. FDC (Liquid Level Measurement)

7.2.1 Design Requirements

Make sure the liquid level measurement is independent of the liquid, which can be achieved using the 3-electrode design described above. Moreover, isolate the sensor from environmental interferences such as a human body, other objects, or EMI.

Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

7.2.2 Detailed Design Procedure

In capacitive sensing systems, the design of the sensor plays an important role in determining system performance and capabilities. In most cases the sensor is simply a metal plate that can be designed on the PCB.

The sensor used in this example is implemented with a two-layer PCB. On the top layer, which faces the tank, there are the 3 electrodes (reference environmental, reference liquid, and level) with a ground plane surrounding the electrodes.

Depending on the shape of the container, the FDC can be located on the sensor PCB to minimize the length of the traces between the input channels and the sensors. In case the shape of the container or other mechanical constraints do not allow having the sensors and the FDC on the same PCB, the traces which connect the channels to the sensor need to be shielded with the appropriate shield.

7.2.2.1 Recommended Initial Register Configuration Values

The application requires 100SPS (T_{SAMPLE} = 10ms). A sensor with an 18-µH inductor and a 33pF capacitor is used. Additional pin, trace, and wire capacitance accounts for 20pF, so the total capacitance is 53pF.

Using L and C, f_{SENSOR} = 1/2π√(LC) = 1/2π√(18 × 10⁻⁶ × 50 × 10⁻¹²) = 5.15MHz. This represents the maximum sensor frequency. When the sensor capacitance is added, the frequency decreases.

Using a system controller clock of 40MHz applied to the CLKIN pin allows flexibility for setting the internal clock frequencies. The sensor coils are connected to channel 0 (IN0A and IN0B pins), channel 1 (IN1A and IN1B pins), and channel 2 (IN2A and IN2B pins).

After powering on the FDC, the FDC enters into Sleep Mode. Program the registers as follows (example sets registers for channel 0 only; channel 1 and channel 2 registers can use equivalent configuration):

1. Set the dividers for channel 0.
   a. The sensor is in an single-ended configuration, therefore set the sensor frequency select register to 2, which means setting field CH0_FIN_SELto b10.
   b. The design constraint for f_{REF0} is > 4 × f_{SENSOR}. To satisfy this constraint, f_{REF0} must be greater than 20.6MHz, so set the reference divider to 1. This is done by setting the CH0_FREF_DIVIDER field to 0x01.
   c. The combined value for Chan. 0 divider register (0x14) is 0x2001.
2. Sensor drive current: to ensure that the oscillation amplitude is between 1.2V and 1.8V, measure the oscillation amplitude on an oscilloscope and adjust the IDRIVE value, or use the integrated FDC GUI feature to determine the optimal setting. In this case, set the IDRIVE value to 15 (decimal), which results in an oscillation amplitude of 1.68V(pk). Set the INIT_DRIVE current field to 0x00. The combined value for the DRIVE_CURRENT_CH0 register (addr 0x1E) is 0x7C00.
3. Program the settling time for Channel 0 (see *Multi-Channel and Single-Channel Operation*).
   a. CHx_SETTLECOUNT > V_{pk} × f_{REFx} × C × π² / (32 × IDRIVE_X) → 7.5, rounded up to 8. To provide margin to account for system tolerances, a higher value of 10 is chosen.
   b. Program Register 0x10 to a minimum of 10.
   c. The settle time is: (10 × 16)/40,000,000 = 4µs
   d. The value for Channel 0 SETTLECOUNT register (0x10) is 0x000A.
4. The channel switching delay is approximately 1µs for f_{REF} = 40MHz (see *Multi-Channel and Single-Channel Operation*)
5. Set the conversion time by the programming the reference count for Channel 0. The budget for the conversion time is : 1/N × (T_{SAMPLE} – settling time – channel switching delay) = 1/3 (10,000 – 4 – 1) = 3.33ms
   a. To determine the conversion time register value, use the following equation and solve for CH0_RCOUNT: Conversion Time (t_{C0})= (CH0_RCOUNT × 16)/f_{REF0}.
   b. This results in CH0_RCOUNT having a value of 8329 decimal (rounded down). Note that this yields an ENOB > 13 bits.

c. Set the CH0_RCOUNT register (0x08) to 0x2089.
6. Use the default values for the ERROR_CONFIG register (address 0x19). By default, no interrupts are enabled
7. Program the MUX_CONFIG register
   a. Set the AUTOSCAN_EN to b1 bit to enable sequential mode
   b. Set RR_SEQUENCE to b10 to enable data conversion on three channels (channel 0, channel 1, channel 2)
   c. Set DEGLITCH to b101 to set the input deglitch filter bandwidth to 10MHz, the lowest setting that exceeds the oscillation tank frequency.
   d. The combined value for the MUX_CONFIG register (address 0x1B) is 0xC20D
8. Finally, program the CONFIG register as follows:
   a. Set the ACTIVE_CHAN field to b00 to select channel 0.
   b. Set SLEEP_MODE_EN field to b0 to enable conversion.
   c. Set SENSOR_ACTIVATE_SEL = b0, for full current drive during sensor activation
   d. Set the REF_CLK_SRC field to b1 to use the external clock source.
   e. Set the other fields to their default values.
   f. The combined value for the CONFIG register (address 0x1A) is 0x1601.

We then read the conversion results for channel 0 to channel 2 every 10ms from register addresses 0x00 to 0x05.

Based on the example configuration above, TI recommends the following register write sequence

is recommended:

Table 7-1. Recommended Initial Register Configuration Values (Multi-Channel Operation)

ADDRESS	VALUE	REGISTER NAME	COMMENTS
0x08	0x8329	RCOUNT_CH0	Reference count calculated from timing requirements (100SPS) and resolution requirements
0x09	0x8329	RCOUNT_CH1	Reference count calculated from timing requirements (100SPS) and resolution requirements
0x0A	0x8329	RCOUNT_CH2	Reference count calculated from timing requirements (100SPS) and resolution requirements
0x10	0x000A	SETTLECOUNT_CH0	Minimum settling time for chosen sensor
0x11	0x000A	SETTLECOUNT_CH1	Minimum settling time for chosen sensor
0x12	0x000A	SETTLECOUNT_CH2	Minimum settling time for chosen sensor
0x14	0x2002	CLOCK_DIVIDER_CH0	CH0_FIN_DIVIDER = 1, CH0_FREF_DIVIDER = 2
0x15	0x2002	CLOCK_DIVIDER_CH1	CH1_FIN_DIVIDER = 1, CH1_FREF_DIVIDER = 2
0x16	0x2002	CLOCK_DIVIDER_CH2	CH1_FIN_DIVIDER = 1, CH1_FREF_DIVIDER = 2
0x19	0x0000	ERROR_CONFIG	Can be changed from default to report status and error conditions
0x1B	0xC20D	MUX_CONFIG	Enable Ch 0 , Ch 1, and Ch 2 (sequential mode), set Input deglitch bandwidth to 10MHz
0x1E	0x7C00	DRIVE_CURRENT_CH0	Sets sensor drive current on ch 0
0x1F	0x7C00	DRIVE_CURRENT_CH1	Sets sensor drive current on ch 1
0x20	0x7C00	DRIVE_CURRENT_CH2	Sets sensor drive current on ch 2
0x1A	0x1601	CONFIG	Enable full current drive during sensor activation, select external clock source, wake up device to start conversion. This register write must occur last because device configuration is not permitted while the FDC is in active mode.

7.2.3 Application Curve

A liquid level sensor with 3 electrodes like the one shown in the schematic was connected to the EVM. The plot shows the capacitance measured by Level sensor at different levels of liquid in the tank. The capacitance of the Reference Liquid and Reference Environmental sensors have a steady value because they experience

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Product Folder Links: *FDC2112-Q1 FDC2114-Q1 FDC2212-Q1 FDC2214-Q1*

consistent exposure to liquid and air, while the capacitance of the level sensor (Level) increases linearly with the height of the liquid in the tank.
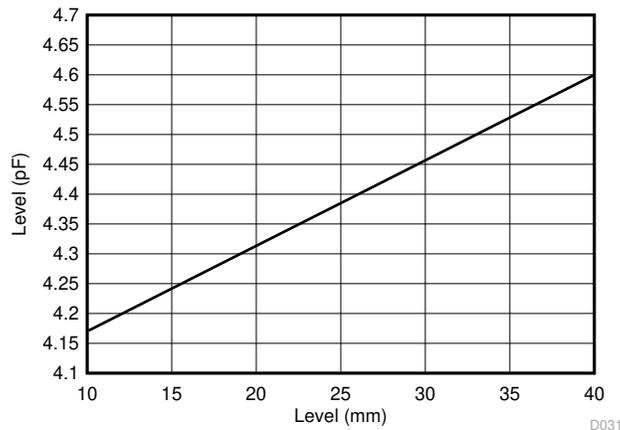

Figure 7-8. Electrode Capacitance vs Liquid Level

7.3 Best Design Practices

- Do leave a small gap between sensor plates in differential configurations. TI recommends a 2mm to 3mm minimum separation.
- The FDC does not support hot-swapping of the sensors. Do not hot-swap sensors, for example by using external multiplexers.

7.4 Power Supply Recommendations

The FDC requires a voltage supply within 2.7V and 3.6V. TI recommends multilayer ceramic bypass X7R capacitors of 0.1µF and 1µF between the VDD and GND pins. If the supply is located more than a few inches from the FDC, additional bulk capacitance can be required in addition to the ceramic bypass capacitors. An electrolytic capacitor with a value of 10µF is a typical choice.

The optimum placement is closest to the VDD and GND pins of the device. Take care to minimize the loop area formed by the bypass capacitor connection, the VDD pin, and the GND pin of the device. See Figure 7-9 and Figure 7-12 for layout examples.

7.5 Layout

7.5.1 Layout Guidelines

- Avoid long traces to connect the sensor to the FDC. Short traces reduce parasitic capacitances between sensor inductor and offer higher system performance.
- Systems that require matched channel response need to have matched trace length on all active channels.

7.5.2 Layout Examples

Figure 7-9 to Figure 7-12 show the FDC2114 / FDC2214 evaluation module (EVM) layout.
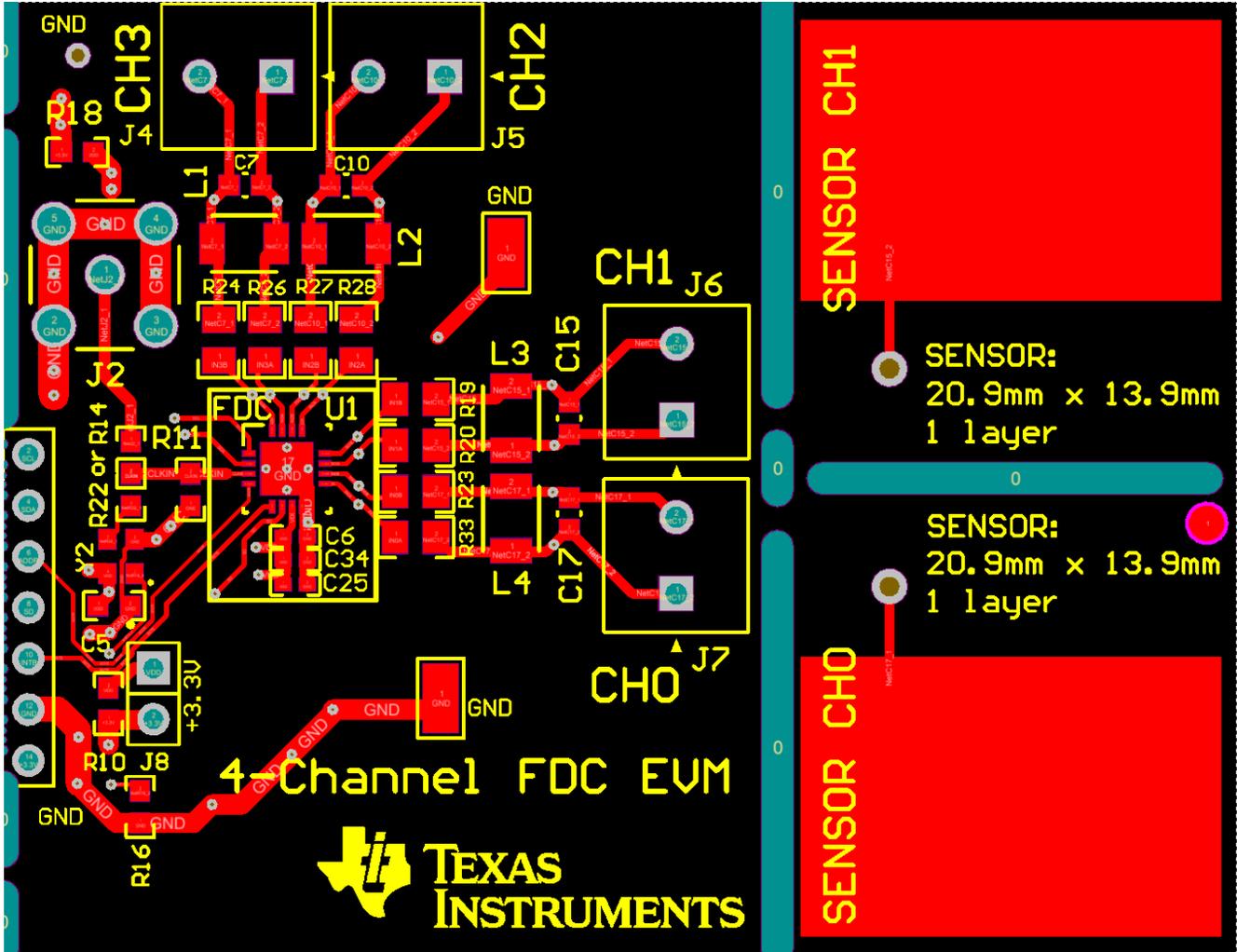
Figure 7-9. Example PCB Layout: Top Layer (Signal)

Figure 7-10. Example PCB Layout: Mid-Layer 1 (GND)
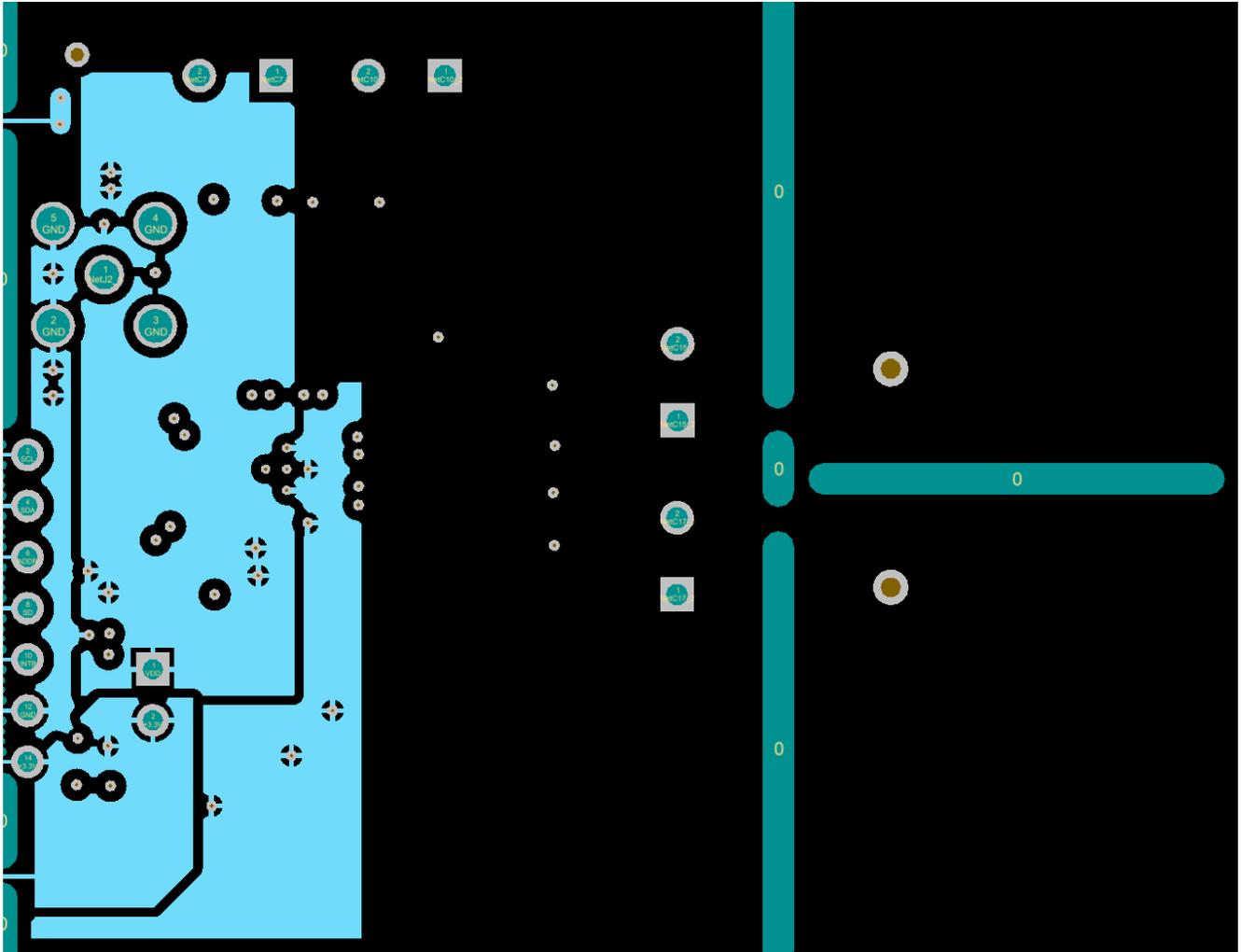
Figure 7-11. Example PCB Layout: Mid-Layer 2 (Power)

Figure 7-12. Example PCB Layout: Bottom Layer (Signal)

8 Device and Documentation Support

8.1 Device Support

8.1.1 Development Support

For related links, see the following:

Texas Instruments' WEBENCH® tool: http://www.ti.com/webench

8.2 Documentation Support

8.2.1 Related Documentation

For related documentation, refer to the following:

For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report (SPRA953)

8.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.4 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

8.5 Trademarks

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8.6 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.7 Glossary

TI Glossary   This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

Changes from Revision * (May 2016) to Revision A (October 2024)   **Page**

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGE OPTION ADDENDUM

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
FDC2112QDNTRQ1	Active	Production	WSON (DNT) | 12	4500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	FDC2112 Q1
FDC2112QDNTRQ1.B	Active	Production	WSON (DNT) | 12	4500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	FDC2112 Q1
FDC2114QRGHRQ1	Active	Production	WQFN (RGH) | 16	4500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	FC2114Q
FDC2114QRGHRQ1.B	Active	Production	WQFN (RGH) | 16	4500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	FC2114Q
FDC2114QRGHTQ1	Obsolete	Production	WQFN (RGH) | 16	-	-	Call TI	Call TI	-40 to 125	FC2114Q
FDC2212QDNTRQ1	Active	Production	WSON (DNT) | 12	4500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	FDC2212 Q1
FDC2212QDNTRQ1.B	Active	Production	WSON (DNT) | 12	4500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	FDC2212 Q1
FDC2212QDNTTQ1	Obsolete	Production	WSON (DNT) | 12	-	-	Call TI	Call TI	-40 to 125	FDC2212 Q1
FDC2214QRGHRQ1	Active	Production	WQFN (RGH) | 16	4500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	FC2214Q
FDC2214QRGHRQ1.B	Active	Production	WQFN (RGH) | 16	4500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	FC2214Q
FDC2214QRGHTQ1	Obsolete	Production	WQFN (RGH) | 16	-	-	Call TI	Call TI	-40 to 125	FC2214Q

(1) Status: For more details on status, see our product life cycle.

(2) Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF FDC2112-Q1, FDC2114-Q1, FDC2212-Q1, FDC2214-Q1 :

- Catalog : FDC2112, FDC2114, FDC2212, FDC2214

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers
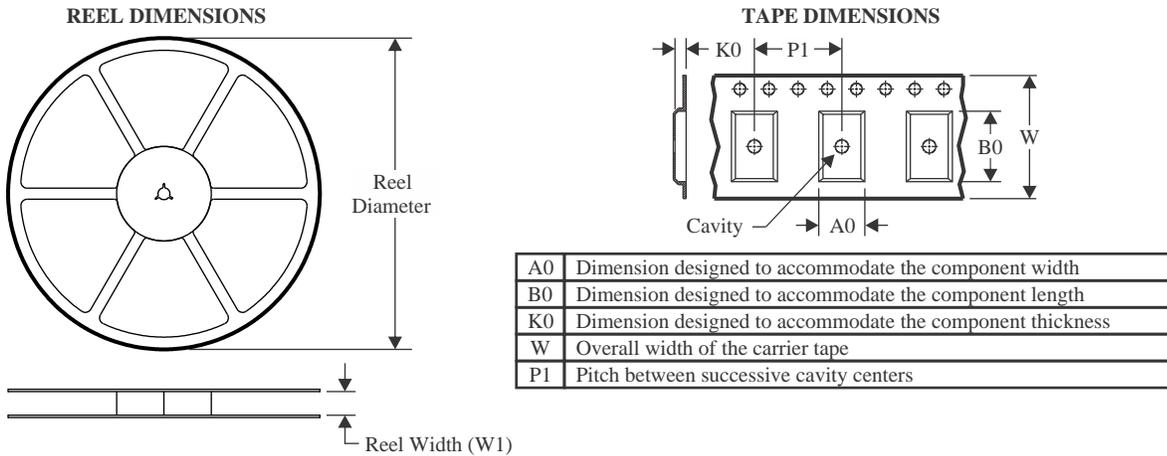
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE
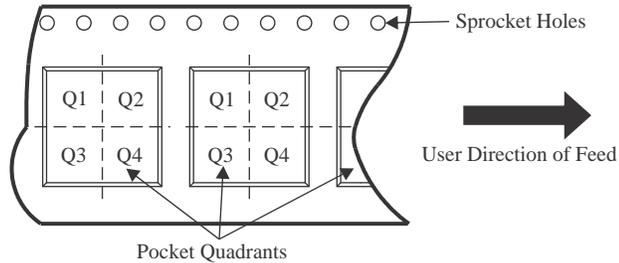
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
FDC2112QDNTRQ1	WSON	DNT	12	4500	330.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
FDC2114QRGHRQ1	WQFN	RGH	16	4500	330.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
FDC2212QDNTRQ1	WSON	DNT	12	4500	330.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1
FDC2214QRGHRQ1	WQFN	RGH	16	4500	330.0	12.4	4.3	4.3	1.3	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

TAPE AND REEL BOX DIMENSIONS
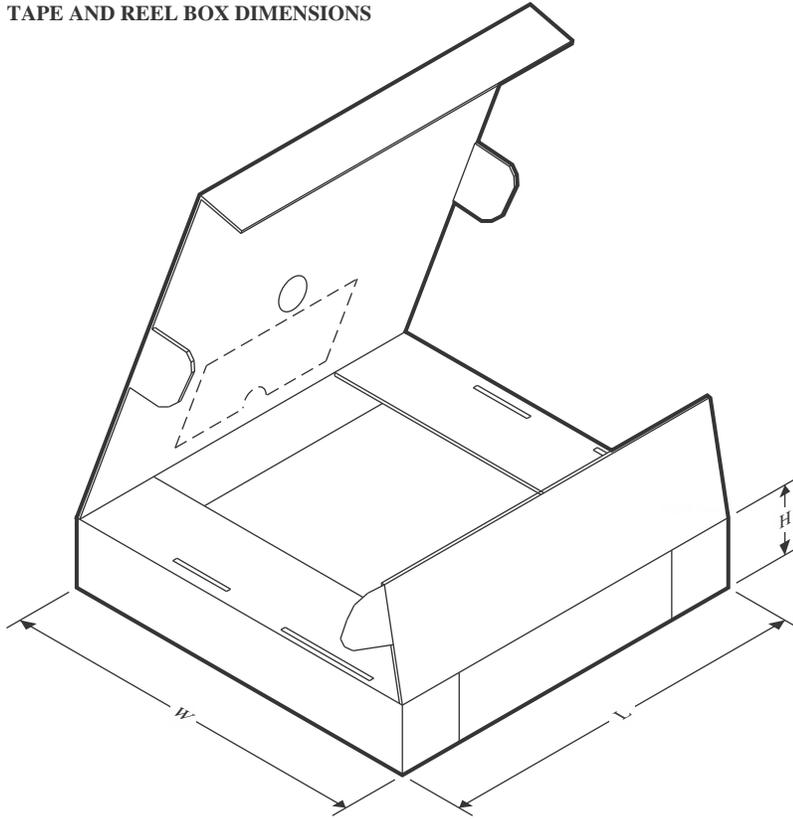
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
FDC2112QDNTRQ1	WSON	DNT	12	4500	356.0	356.0	36.0
FDC2114QRGHRQ1	WQFN	RGH	16	4500	356.0	356.0	36.0
FDC2212QDNTRQ1	WSON	DNT	12	4500	356.0	356.0	36.0
FDC2214QRGHRQ1	WQFN	RGH	16	4500	356.0	356.0	36.0

B | 4.1 / 3.9 | A

PIN 1 INDEX AREA

4.1 / 3.9

0.5 / 0.3

0.3 / 0.2

DETAIL
OPTIONAL TERMINAL
TYPICAL

DIM A	
OPT 1	OPT 1
(0.1)	(0.2)

0.8 MAX

0.05 / 0.00

C

SEATING PLANE

| | 0.08 |

□ 2.6 ± 0.1

5   8

SEE TERMINAL DETAIL

12X | 0.5

4

4X | 1.5

17

1

EXPOSED THERMAL PAD

9

SYMM ₵

12

16X 0.3 / 0.2

| ⊕ | 0.1 Ⓜ | C | A | B |
| | 0.05 Ⓜ | | | |

PIN 1 ID (OPTIONAL)

16   SYMM ₵   13

16X 0.5 / 0.3

(A) TYP
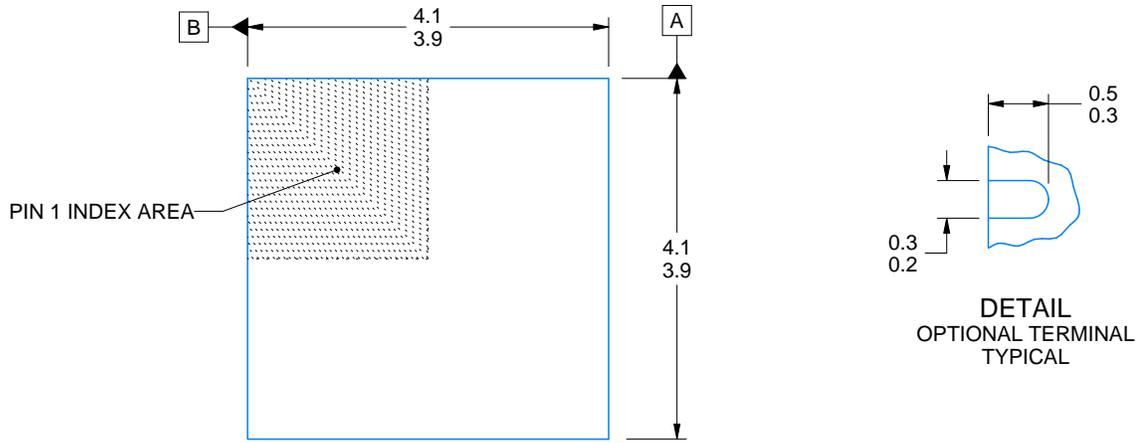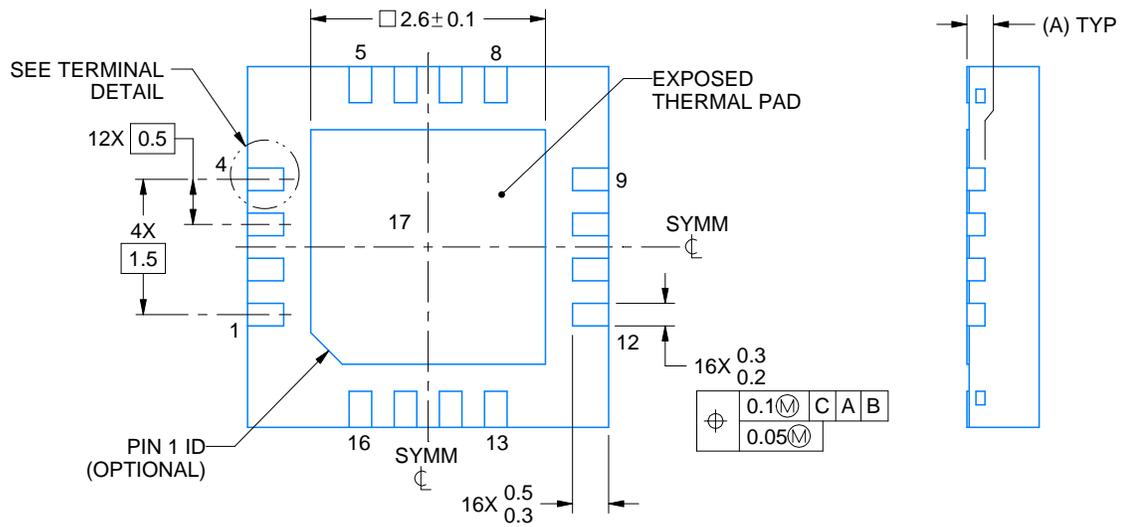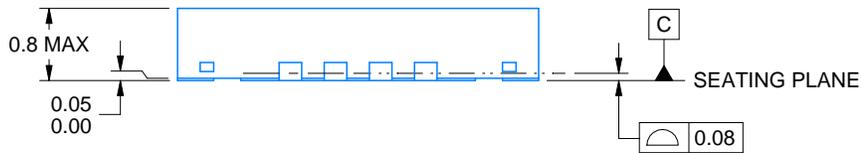
4214978/B   01/2017

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

RGH0016A

(☐ 2.6)

SYMM

16   13

16X (0.6)

1

16X (0.25)

17   SYMM

(3.8)

(1)

12X (0.5)   4

9

(⌀ 0.2) TYP
VIA

(R0.05)
TYP

12

5   8

(1)

(3.8)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X

0.07 MAX
ALL AROUND

METAL

EXPOSED METAL

SOLDER MASK
OPENING

NON SOLDER MASK
DEFINED
(PREFERRED)

0.07 MIN
ALL AROUND

SOLDER MASK
OPENING

EXPOSED METAL

METAL UNDER
SOLDER MASK
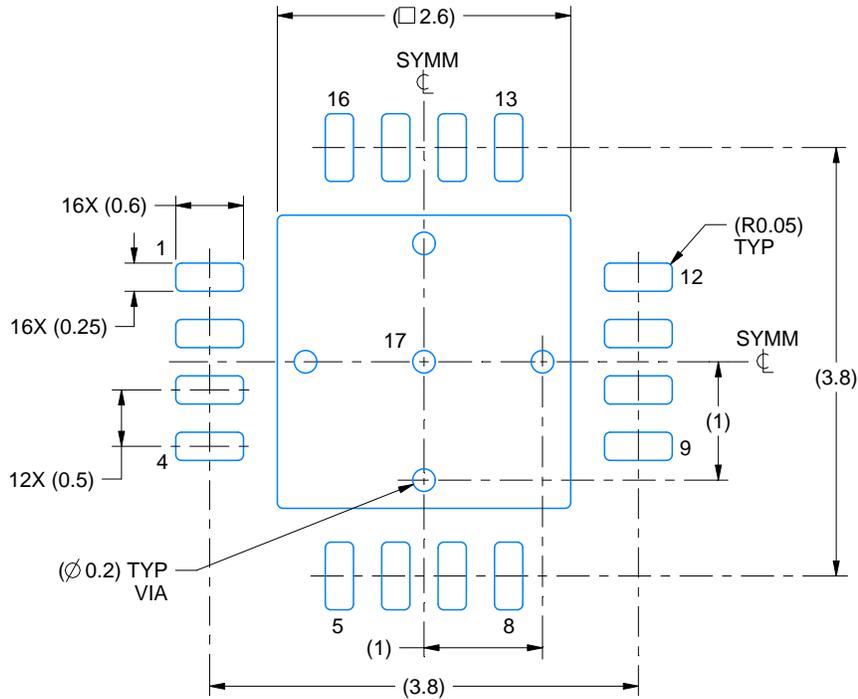
SOLDER MASK
DEFINED
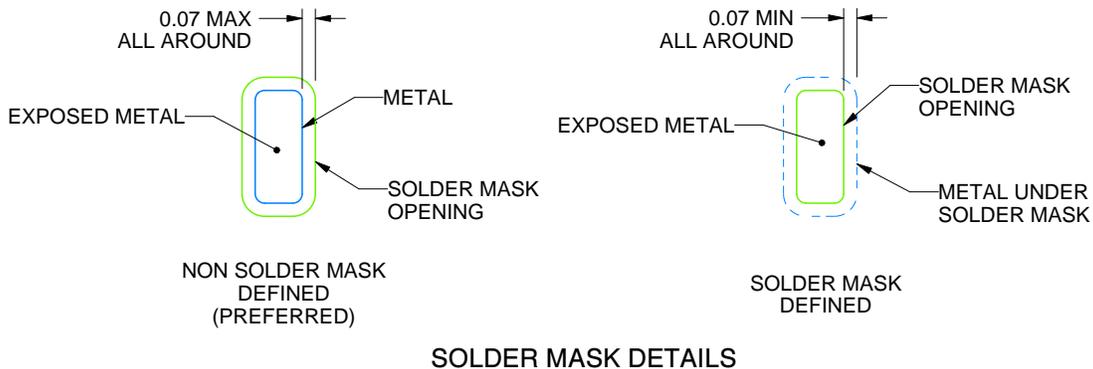
SOLDER MASK DETAILS

4214978/B   01/2017

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature
   number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown
   on this view. It is recommended that vias under paste be filled, plugged or tented.

4X (□ 1.15)

(0.675) TYP

16

13

16X (0.6)

1

17

16X (0.25)

12

(0.675) TYP

SYMM ₵

12X (0.5)

(3.8)

4

9

EXPOSED METAL TYP

(R0.05) TYP

5

SYMM ₵

8

(3.8)

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 17
78% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:20X

4214978/B   01/2017

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate
   design recommendations.

4214928/C   10/2021

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

12X (0.6)

(2.6)

SYMM

1

12X (0.25)

SYMM

12

(1.25)

(3)

10X (0.5)

6

7

(R0.05) TYP

(Ø 0.2) VIA
TYP

(1.05)

(3.8)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X

0.07 MAX
ALL AROUND

EXPOSED METAL

SOLDER MASK
OPENING

METAL

NON SOLDER MASK
DEFINED
(PREFERRED)

0.07 MIN
ALL AROUND

EXPOSED METAL

METAL UNDER
SOLDER MASK

SOLDER MASK
OPENING

SOLDER MASK
DEFINED

SOLDER MASK DETAILS

4214928/C   10/2021

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

SYMM

METAL TYP

12X (0.6)

12X (0.25)

10X (0.5)

(R0.05) TYP

(0.68)

12

7

6

1

(0.76)

SYMM

4X (1.31)

4X (1.15)

(3.8)
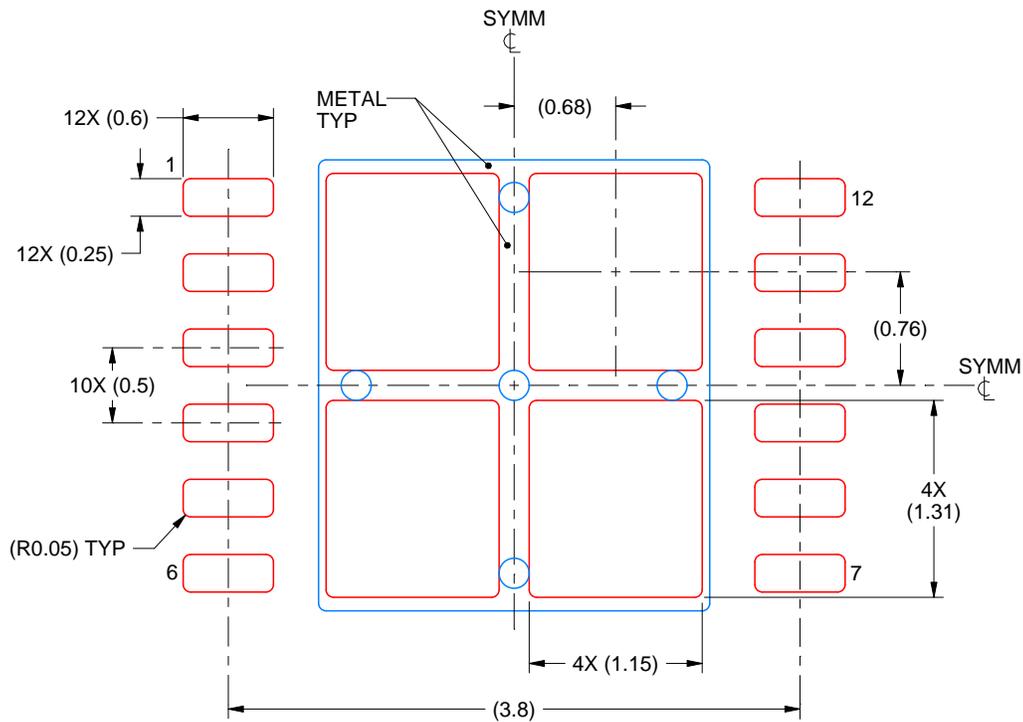
SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
77% PRINTED SOLDER COVERAGE BY AREA
SCALE:20X

4214928/C   10/2021

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.